

# MASTR

## **Progress Line**

25-50 MHz RECEIVER MODELS 4ER39C68-85 (WITH NOISE BLANKER)



## **SPECIFICATIONS**

FCC Filing Designation

Frequency Range

Audio Output

Sensitivity

12-dB SINAD (EIA Method) 20-dB Quieting Method

Selectivity

EIA Two-Signal Method 20-dB Quieting Method

Spurious Response

First Oscillator Stability

Modulation Acceptance

Squelch Sensitivity

Critical Squelch Maximum Squelch

Intermodulation (EIA)

Maximum Frequency Separation

Frequency Response

ER-39-C

25-50 MHz

5 watts at less than 5% distortion

0.25 μV

0.35 μV

-85 dB (adjacent channel, 20 kHz channels)

-100 dB at  $\pm 15~\mathrm{kHz}$ 

-100 dB

 $\pm .0005\%$  (-30°C to +60°C)

±7 kHz (narrow-band)

 $0.15 \mu V$ 

Greater than 20 dB quieting (less than 1.5 µV)

-65 dB

0.4%

+1 and -8 dB of a standard 6-dB per octave de-emphasis curve from 300 to 3000 Hz (1000-Hz reference)

\*These specifications are intended primarily for the use of the serviceman. Refer to the appropriate Specification Sheet for the complete specifications.

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#### --- WARNING ---

No one should be permitted to handle any portion of the equipment that is supplied with high voltage; or to connect any external apparatus to the units while the units are supplied with power.

#### KEEP AWAY FROM LIVE CIRCUITS

#### **DESCRIPTION**

General Electric MASTR Progress Line Receiver Type ER-39-C is a double conversion, superheterodyne FM receiver designed for operation on the 25-50 megahertz band.

The receiver is of single-unit construction and is completely housed in a copper-plated aluminum casting for maximum shielding and rigidity. The top compartment of the casting contains the RF, oscillator, converter, and 1st low IF amplifier, and noise blanker. The bottom portion of the casting contains the audio-squelch board and the optional Channel Guard board.

#### CIRCUIT ANALYSIS

The MASTR Progress Line Receiver is completely transistorized, using silicon transistors throughout for added reliability. Input leads to the receiver are individually

filtered by the 20-pin feed-through by-pass connector J443. A regulated +10 volts is used for all receiver stages except the audio PA stage which operates from the 12-volt system supply.

Centralized metering jack J442 is provided for use with General Electric Test Set Model 4EX3A10 or 4EX8K11 for ease of alignment and servicing. The Test Set meters the noise blanker, multiplier, and limiter stages as well as the discriminator, and regulated 10 volts.

#### RF AMPLIFIERS (A341 & A344)

lst RF Amplifier (A341) consists of two high-Q helical resonators and an RF amplifier stage (Q2). The RF signal from the antenna is coupled by RF cable W441 to a tap on L341/L343/L345. The tap is positioned to insure the proper impedance match to the antenna. RF energy is coupled through the two coils by an opening in the shield wall to the base of 1st RF Amplifier

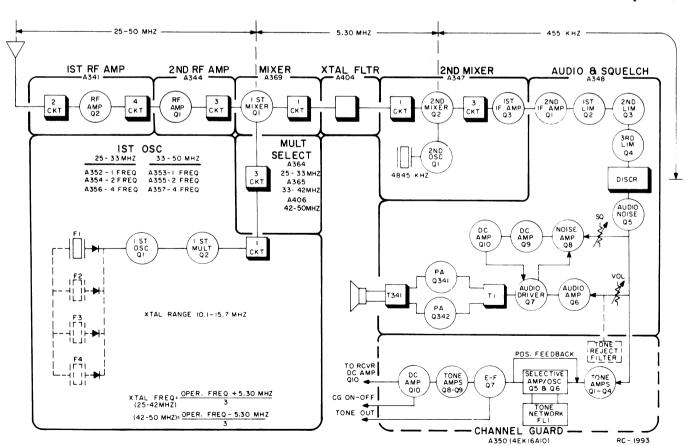


Figure 1 - Receiver Block Diagram

Q1. The coils are tuned to the incoming frequency by air trimmer capacitors C341 and C342.

The 1st RF amplifier uses a Field-Effect Transistor (FET) as the active device. The FET may be considered a semiconductor current path (or channel) whose resistance is varied by a voltage applied between the "gate" and "source" terminals. Lead identification for the FET is shown in Figure 2). The FET has voltage-controlled characteristics, and may be compared to a vacuum tube in operation (see Figure 2).

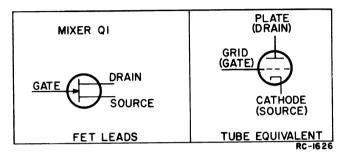


Figure 2 - FET Nomenclature

RF from the antenna is applied to the "source" terminal of FET Q1. Q1 operates as a grounded-gate amplifier. This method of operation provides a low impedance input to the amplifier. The amplified output is taken from the "drain" terminal and coupled through three tuned circuits to the 1st mixer.

The output of A341-Q1 is taken from the drain and is coupled through two or four tuned circuits to the base of 2nd RF Amplifier A344-Q1.

The output of the 2nd RF Amplifier is coupled through three tuned circuits to the base of 1st Mixer A369-Q1.

#### 1ST OSCILLATOR AND MULTIPLIER (A352-A357)

The receiver 1st oscillator operates in a transistorized Colpitts oscillator circuit. The oscillator crystal operates in a fundamental mode at a frequency of approximately 10 to 15 megahertz. The crystal is cut to provide temperature compensation at the high end of the temperature range and is thermistor compensated at low temperatures. This provides ±.0005% frequency stability as soon as the receiver is energized — without the warm-up time required by crystal ovens or warmers.

In single frequency receivers, bias for the oscillator is obtained by a jumper from H1 to H2 on the oscillator board.

In multi-frequency receivers, a diode is connected in series with the crystal,

and up to three additional crystal circuits can be added. The 10-volt jumper is removed and the proper frequency is selected by switching the desired crystal circuit to +10 volts by means of a frequency selector switch on the control unit.

Switching the +10 volts to the crystal circuit forward biases the diode and reduces its impedance. This applies the crystal frequency to the base of oscillator transistor Q1. Feedback for the oscillator is developed across C21/C22. The output is coupled to the base of 1st multiplier Q2.

The output of the 1st multiplier (tripler Q2) is transformer-coupled (T3/T4) to multiplier selectivity assembly A364/A365. The multiplier tank is tuned to three times the crystal frequency. The stage is metered at centralized metering jack J442-4 through metering network CR1, R1, C5 and C6.

#### MULTIPLIER SELECTIVITY (A364/A365/A404)

Following the 1st multiplier tank (T3/T4) are two additional L-C tuned circuits (L1, L2 and L3). Capacitor C34/C35/C36 couples the multiplier selectivity output to the base of the first mixer.

#### 1ST MIXER (A345) AND CRYSTAL FILTER (A404)

The 1st mixer uses a Field-Effect
Transistor (FET) as the active device
(Figure 2). The FET has several advantages
over a conventional transistor, including
a high input impedance, high power gain, and
an output that is relatively free of harmonics
(low in intermodulation products).

In 1st mixer A345, RF from the 1st RF amplifier and injection voltage from the multiplier selectivity assembly are applied to the gate of Q1. The mixer output is taken from the drain with the output tuned to the 5.3 MHz high IF frequency.

A highly selective crystal filter (A404) following the 1st mixer provides the major selectivity for the receiver. The output of the filter is fed through impedance matching transformer A347-Tl to the base of the 2nd mixer.

2ND OSCILLATOR, 2ND MIXER AND 1ST LO IF AMPLIFIER (A347)

A347-Ql operates in a Colpitts oscillator circuit, with feedback supplied through C4. The oscillator low-side injection voltage (4845 kHz) is applied to the base of the 2nd mixer.

The High IF signal from the filter and the injection voltage from the 2nd oscillator is applied to the base of 2nd mixer Q2. The 455 kHz mixer output is applied to three tuned low IF circuits, L1, L2 and L3. These tuned circuits are required for shaping the

nose of the IF waveform, and for rejecting any undesired output frequencies from the 2nd mixer.

The low IF signal is applied to the base of 1st low IF amplifier A347-Q3. The output of A347-Q3 is R-C coupled to the base of the 2nd low IF amplifier.

#### 2ND LO IF AMPLIFIER AND LIMITERS (A348)

Additional amplification of the low IF signal going to the limiter stages is provided by 2nd low IF amplifier A318-Q1. This stage is metered at J442-2 through a metering network consisting of C19, CR3 and R25.

Following the 2nd low IF amplifier are three R-C coupled limiter stages (A348-Q2, Q3 and Q4). The 1st limiter is metered at J442-3 through metering network C20, CR4 and R26.

#### DISCRIMINATOR (A348)

The limiter output is applied to a Foster-Seely type discriminator, where diodes CR1 and CR2 rectify the 455-kHz signal to recover the audio. The discriminator is metered at J442-10 through metering network C16 and R23.

#### AUDIO - NOISE AMPLIFIER (A348)

The discriminator output is coupled through a low-pass filter (C16, C18, R21 and R22) to the base of audio-noise amplifier Q5. The filter removes any 455-kHz signal remaining in the discriminator output. Q5 operates as an emitter-follower to match the discriminator impedance to the VOLUME control, SQUELCH control, and Channel Guard input. The stage also provides power gain.

#### AUDIO AMPLIFIERS (A348)

Any audio present in the incoming signal is coupled from the emitter of Q5 through the VOLUME control and a de-emphasis network to the base of audio amplifier Q6. The de-emphasis network consists of C22, C23, R30 and R31.

Audio driver Q7 follows the audio amplifier. The audio output of Q7 is coupled through transformer T1 to provide phase inversion for the push-pull audio PA stage.

Q341 and Q342 operate as a push-pull, class AB audio PA stage. The PA output is coupled through audio transformer T341 to the loudspeaker. The yellow and white tertiary windings of T341 supply balanced feedback to the collector of Q7. The feedback winding minimizes distortion and prevents the pick-up of external electrical noise.

The PA stage provides a 5-watt output at less than 5% distortion into a 3.5-ohm load at the receiver output terminals (3.2-ohms at the Control Unit). Base bias for the PA stage and the elimination of crossover distortion is controlled by bias adjust potentiometer R43. The potentiometer is set at the factory as shown in STEP 1 of the receiver Test Procedure.

- NOTE -

Do not adjust bias adjust potentiometer R43 unless PA transistors Q341 and Q342 have been replaced.

Audio high and low are also present at centralized metering jack J442, and can be used as shown in STEP 1 of the Test Procedure.

#### SQUELCH (A348)

Noise from the audio-noise amplifier operates the squelch circuit. With no carrier present in the receiver, this noise is coupled to the base of noise amplifier Q8 through a high-pass filter which attenuates frequencies below 3 kHz. The filter consists of C30, C31 and R45, as well as C34 and L3 in the collector circuit of Q8. The gain of Q8 is determined by the Squelch control, which varies the bias on the base of Q8. Thermistor RT2 keeps the critical squelch constant over wide variations in temperature.

The output of noise amplifier Q8 is rectified by diodes CR5 and CR6, and filtered by C36 and C37 to produce a negative DC voltage. This DC voltage is applied to the base of DC amplifier Q9, turning it off. When turned off, the collector voltage of Q9 rises to approximately 8 volts, turning on DC amplifier Q10. When conducting, the collector voltage of Q10 drops to almost ground potential, which removes the base bias to audio amplifier Q6 and audio driver Q7, turning them off.

When the receiver is quieted by a signal (unsquelched), the noise in the receiver is reduced, turning DC amplifier Q9 on and DC amplifier Q10 off. This allows the audio stages to conduct so that sound is heard in the speaker. A network composed of C38, CR7 and R62 slows down the switching action of Q10, preventing an obnoxious "thump" from being heard in the speaker.

Resistor R53 connects from the emitter of audio driver Q7 to the emitter of noise amplifier Q8, providing a hysteresis loop in the squelch circuit. When a weak signal opens the squelch, the signal level may be reduced by 4 to 6 dB without the squelch closing. This limits squelch "flutter" or "picket-fence" operation.

With audio driver Q7 conducting, a positive voltage through R53 helps to reduce the gain of noise amplifier Q8. This positive feedback provides a quick, positive switching action in the squelch circuit. When the receiver squelches, audio driver Q7 turns off and its emitter potential drops to zero. This reduces the DC feedback through R53 to the emitter of noise amplifier Q8. Reducing the feedback causes Q8 to conduct harder, turning the audio stages off quickly.

Keying the transmitter removes the +10 volts from J19, turning off DC amplifier Q9 and turning on Q10 to mute the receiver.

#### NOISE BLANKER (A370/A372 - Figure 3)

An RF signal and noise pulse from the antenna is fed simultaneously to the Noise Blanker 1st RF Amplifier and the receiver 1st RF amplifier sections. The signal and noise is transformer coupled through T1/T2/T3 to the base of the first of two RF amplifier stages. The amplifier stages (Q1, Q2) raise the level of the noise pulse which is coupled through T10/T11/T12 and L10 to the base of the pulse detector Q3. A metering network consisting of R22, C21, and C17 permits the blanker to be metered at centralized metering jack J442-11.

Base bias for the pulse detector is established by R9 and CR1. CR1 is normally conducting, which keeps Q3 in a barely conducting state. A noise pulse applied to the base of Q3 causes it to conduct heavily. This results in a negative pulse at the out-

put (collector) of Q3. Following Q3 is a low-pass RF filter consisting of C18, C22 and L5.

The output of the filter is fed to the base of pulse amplifier Q4. This stage is biased by CR3, R12 and R13 so that it is just conducting. The negative-going pulse from the pulse detector cuts CR3 off, which biases Q4 on, and a positive pulse appears at the output of pulse amplifier Q4.

Q5 and Q6 form part of the one-shot multivibrator circuit. Bias voltage through R17 keeps Q5 normally turned on. The positive voltage at the collector of Q5 keeps Q6 turned off. The positive-going pulse from the pulse amplifier (Q4) is fed to the base of Q5, cutting the stage off. As Q5 cuts off, Q6 is turned on; and the output is an 8-volt, 12 to 18 microsecond positive-going blanking pulse. The positive blanking pulse is fed to the emitter of 2nd RF Amplifier A344-Q1 and coil L2. The pulse cuts off Q1 and shunts L2 for the duration of the noise pulse.

The positive blanking pulse to the emitter of the 2nd RF amplifier A344-Q1 is controlled by the RF Level Shut-Off Switch A376. The output of the 1st Mixer is fed through a low-pass filter network in the RF level switch circuit to the base of the high IF level amplifier Q1. When the antenna signal input level is approximately 500-5000 microvolts, the high IF level output of Q1 is sufficient to turn level ON level-sensitive switch Q2. The output of Q2 is filtered through C7, C8, L2 and then turns ON the Noise Blanker (A370/A372)

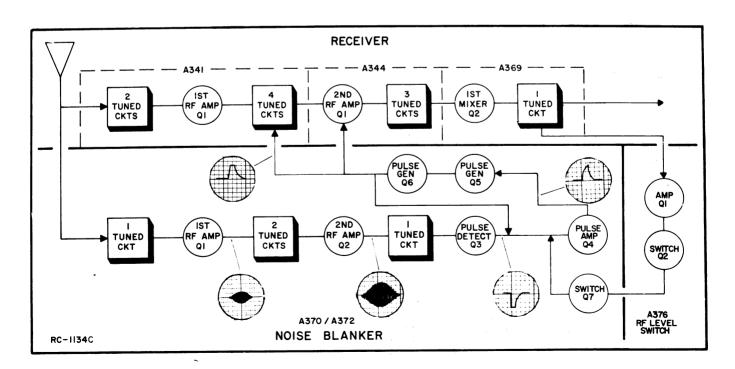


Figure 3 - Noise Blanker Block Diagram

switch Q7. The conduction of Q7 changes the bias to the 1st Pulse Amplifier Q4 and shorts the blanking pulse to ground.

The high IF output level (amplified by Q1) is not sufficient to turn Q2 ON when the antenna signal input is below the 500 to 5000 microvolt range. As a result, Q7 does not turn ON, and the positive blanking pulse is fed to the emitter of the 2nd RF Amplifier A344-Q1.

The blanking width is determined by R17 and C27. Diode CR6 keeps the output pulse a square wave. CR5 prevents oscillation at temperature extremes.

At the same time that the blanking pulse is applied to the receiver, samples of the pulse are fed to automatic repetition rate switch C30, C24, CR4, R13, R14 and R20. The pulse sample is coupled through C30 and is rectified by CR4. The rectified voltage charges C24 which then discharges through R13 and R14 to reverse bias CR3 and turn off pulse amplifier Q4. The components (C23, C24, R13 and R14) are selected so that the output pulses cannot blank the receiver continuously and prevent the desired signal from being heard.

The circuit time constant disables the blanking function whenever sinusoidal intermodulation signals produce beat frequencies of two kHz or higher. However, continuous impulse noise will not disable the blanker until a repetition rate of approximately 10 to 20 kHz is exceeded. The higher impulse noise repetition rate is provided by C23 which bypasses CR3 with the negative-going impulse noise. This turns on Q4 and allows the blanker to function.

As the noise signal from the antenna is applied to the Noise Blanker, the RF signal is applied to the receiver RF amplifier (A341). The six tuned circuits in the receiver front end provide a time delay for the RF signal, which enables the blanking pulse from the noise blanker to cut off the RF amplifier in the receiver before the noise pulse can get there.

The blanker may be disabled by shorting across the yellow dot on the noise blanker printed wiring board. Refer to the Noise Blanker Troubleshooting Procedure (as listed in the Table of Contents) for a complete performance check.

#### CHANNEL GUARD

Channel Guard Board Model 4EK16A10 is a fully transistorized encoder-decoder for use with MASTR Professional Series mobile and station combinations. The tone frequencies are controlled by plug-in tone networks that are made with precision components for excellent stability and reliability. The tone frequencies range from 71.9 to 203.5 Hz.

#### Encoder (A350)

Keying the transmitter removes the receiver mute +10 volts, and forward biases feedback control diode CR5, causing it to conduct. When conducting, the diode shunts R39, R35 and C19. This provides the necessary gain to the base of Q5 to permit oscillation.

The encoder tone is provided by selective amp-oscillator transistors Q5 and Q6 which oscillate at a frequency determined by the tone network. Negative feedback applied through the tone network to the base of Q5 prevents any gain in the stage except at the desired encode frequency.

Starting network R45, C21, C22 and CR6 provide an extremely fast starting time for the encoder tone. Keying the transmitter removes the receiver mute +10 volts, causing a pulse to be applied to the base of Q6 to quickly start the oscillator. Thermistor-resistor combination R32 and RT1 provides temperature compensation for the oscillator output. Limiter diodes CR3 and CR4 keep the tone amplitude constant.

Emitter-follower Q7 follows the oscillator circuit. The encoder tone is taken from the emitter of Q7 and applied to the transmitter.

#### Decoder (A350)

The decoder function is designed to eliminate all calls that are not tone coded for the Channel Guard frequency. As long as the CHANNEL GUARD-OFF switch on the control unit is left in the CHANNEL GUARD position, all signals are locked out except those from transmitters that are continuously tone coded for positive identification by the receiver.

Placing the CHANNEL GUARD-OFF switch in the OFF position instantly disables the Channel Guard operation so that all calls on the channel can be heard. When the hookswitch option is used, lifting the microphone from its hanger disables the Channel Guard Circuit.

Audio, tone and noise are taken from the emitter of the receiver audio-noise amplifier A348-Q5 and is fed through A350-J1 to four tone amplifier and bandpass filter circuits. The filters remove the audio and high-frequency noise from the signal, and the tone amplifiers provide sufficient gain to insure clipping by limiter diodes CR1 and CR2. The clipping action eliminates variation in the squelch performance due to changes in tone deviation. The signal is then applied to selective amplifiers Q5 and Q6 which amplify only the tone determined by the tone network.

The output of the selective amplifier is applied through emitter-follower Q7 to

the high gain, broad-band tone amplifiers Q8 and Q9. The output of Q9 is rectified by detector diodes CR7 and CR8, and the resulting negative DC voltage controls the squelch gate. Q8 is normally biased for low gain. When the tone is detected by CR7 and CR8, feedback is provided through R54 to quickly change the bias on Q8 for full gain. This ensures a more positive "unsquelching" action.

Squelch gate diode CR9 is normally forward biased by a positive DC voltage (approximately 1.5 volts) fed through R58. The forward bias causes CR9 to conduct, feeding a DC voltage to the base of DC amplifier A348-Q10 in the receiver. This removes the bias on the receiver audio stages and holds them off.

When the proper tone is applied to the decoder, the negative DC voltage from the detector diodes back-biases squelch gate diode CR9 and cuts off the positive bias to the receiver DC amplifier A348-Q10. However, the receiver noise squelch circuit continues to operate until a carrier quiets the receiver.

Placing the CHANNEL GUARD - OFF switch in the OFF position (or removing the microphone from its hookswitch) removes the ground to the base of the decoder DC switch (Q10), causing it to conduct. This backbiases squelch control diode CR9 and cuts off the positive bias to the receiver DC amplifier (A348-Q10). The receiver noise squelch circuit continues to operate until a carrier quiets the receiver.

A tone rejection filter connected in parallel with A348-Jl2 (in the receiver) bypasses any incoming tone to ground. This attenuates the tone level reaching the receiver audio circuits. The filter is composed of C26, C27, C28, C29, L1 and R59.

An optional tone reject filter (A402) that is identical to the filter described

above is available for use in two-way radios with transmitter Channel Guard only.

#### MAINTENANCE

#### DISASSEMBLY

To service the receiver from the top--

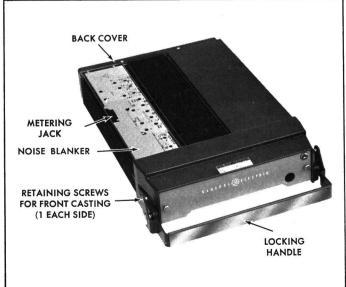
- Pull locking handle down and pull radio about one inch out of mounting frame.
- 2. Pry up cover at rear of receiver.
- 3. Slide cover back and lift off.

To remove the receiver from the system frame--

- Loosen the two Phillips-head retaining screws in front casting (see Figure 4), and pull casting away from system frame.
- Remove the four screws in the back cover.
- 3. Remove the two screws holding the receiver at each end of the system frame.
- 4. Disconnect the antenna jack and the 20-pin connector from the front of the receiver, and slide the unit out of the system frame.

To service the receiver from the bottom--

- Pull locking handle down. Pull radio out of mounting frame.
- 2. Remove screws in bottom cover. Pry up cover at back of receiver.
- 3. Slide cover back and lift off.



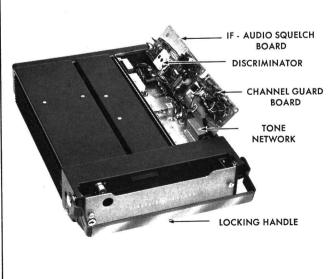


Figure 5 - Removing Bottom Cover

#### FRONT END ALIGNMENT

#### EQUIPMENT REQUIRED

- 1. GE Test Set Models 4EX3A10, 4EX8K10, 11 ( or 20,000 ohms-per-volt Multimeter with a 1-volt scale).
- 2. A 455 kHz and 25-50 MHz signal source. Connect a one-inch piece of insulated wire no larger than .065-inch diameter to generator output probe.

#### PRELIMINARY CHECKS AND ADJUSTMENTS

METERING POSITION GE Test | Multimeter STEP | Set | - at J442

- 1. Connect Test Set to Receiver Centralized Metering Jack J442 and set meter sensitivity switch to the TEST 1 position (or 1-volt position on 4EX8K10, 11).
- 2. With Test Set in Position J, check for regulated +10 volts. If using Multimeter, measure from C360 to C361.

TUNING CONTROL READING

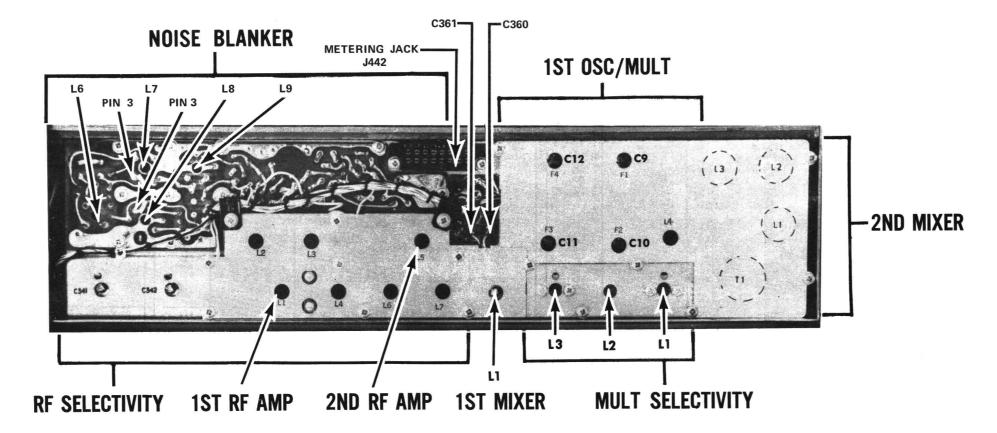
OSCILLATOR/MULTIPLIER

PROCEDURE

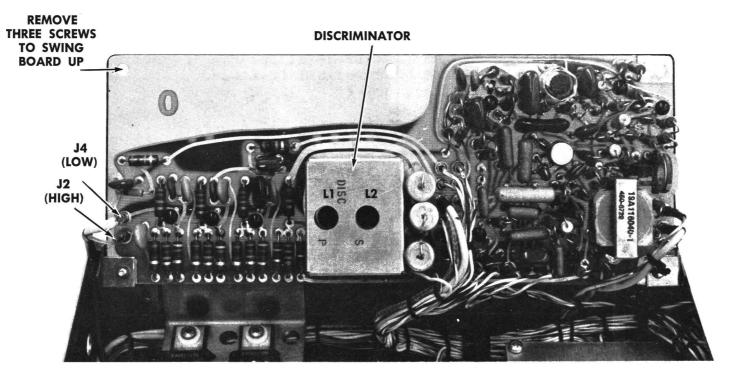
- 3. If using Multimeter, connect the positive lead to J442-16 (Ground).
- 4. Disable Channel Guard.

#### ALIGNMENT PROCEDURE

	_		OSCIEMATOR, MOETI		
1.	D (MULT-1)	Pin 4	L4 (on 1st OSC/MULT) and L1, L2 (on MULT SELECTIVITY)	See Pro- cedure	Tune L4 on 1st OSC/MULT and L1 on MULT SELECTIVITY for maximum meter reading. Next, tune L2 for minimum meter reading. Then tune L3 for maximum meter reading. Repeat step 1, changing voltage scale if necessary.
			RF AMPLIFIER & SELE	CTIVITY	
2.	A (DISC)	Pin 10		Zero	Apply an on-frequency signal adjacent to L7. Adjust the signal generator for discriminator zero.
3.	B (2nd IF Amp)	Pin 2	L1 (1st RF Amp), L6, L7, C341 and C342 (RF SELEC- TIVITY)	Maximum	Apply an on-frequency signal to the antenna jack, keeping below saturation. Tune L1 thru L7, C341, and C342 for maximum meter reading.
4.	"	"	L4 (1st OSC/MULT) and L1 and L2 (MULT SELECTIVITY)	Maximum	Apply an on-frequency signal as above, keeping below saturation. Tune L4 on 1st OSC/MULT and L1, L2 and L3 on MULT SELECTIVITY for maximum meter reading.
			FREQUENCY ADJUST	MENT	
5.	A (DISC)	Pin 10	C9 on 1st OSC (C10, C11 or C12 for multi- frequency)	Zero	Apply an on-frequency signal to the antenna jack. Tune C9 for zero discriminator reading. In multi-frequency units, tune C10, C11 or C12 as required.



## **IF-AUDIO & SQUELCH**



#### COMPLETE RECEIVER & NOISE BLANKER ALIGNMENT

#### EQUIPMENT REQUIRED

- 1. GE Test Set Models 4EX3A10, 4EX8K10, 11 (or 20,000 ohms-per-volt Multimeter with a 1-volt scale).
- 2. A 455 kHz signal cource (GE Test Set Model 4EX7A10) and 25-50 MHz signal cource. Connect a one-inch piece of insulated wire no larger than .065-inch diameter to generator output probe.

#### PRELIMINARY CHECKS AND ADJUSTMENTS

- 1. Connect Test Set to Receiver Centralized Metering Jack J442, and set meter sensitivity switch to the TEST 1 position (or 1-volt position
- 2. For large changes in frequency or a badly mis-aligned receiver, set crystal trimmer C9 to mid-capacity. In multi-frequency receivers, set C10, C11 or C12 to mid-capacity as required. Where the maximum frequency spacing is less than 100 kHz, align the unit on channel F1. If the frequency spacing is greater than 100 kHz, align the receiver on the center frequency.
- 3. With Test Set in Position J, check for regulated +10 volts. If using Multimeter, measure from C360 to C361.
- 4. If using Multimeter, connect the positive lead to J442-16 (Ground).
- For large changes in frequency or a badly mis-aligned receiver, adjust all slugs on the Noise Blanker to the bottom of the coil form (closest to printed wiring board).
- 6. Disable the Channel Guard.

	METERIN	G POSITION							
STEP	GE Test Set	Multimeter - at J442	TUNING CONTROL	METER READING	PROCEDURE				
				DISCRIMINA	TOR & OSCILLATOR				
1.	A (DISC)	Pin 10	Remove three screws and swing open the IF-AUDIO & SQUELCH board. Adjust L1 (disc primary) 1/2 turn counterclockwise from the bottom of coil. Next, apply a 455-kHz signal to J2 and J4 and adjust L2 (disc secondary) for zero meter reading.						
2.	A (DISC)	Pin 10		See Procedure  Alternately apply a 450-kHz and 460-kHz signal and check for recedure of at least 0.3 volt, but not more than 0.5 volt on GE Test Set readings must be within .05 volt. Do not attempt to balance read any closer than 0.05 v.					
3.	D (MULT-1)	Pin 4	L4 (on 1st OSC/MULT) and L1, L2 & L3 (on MULT SELECTIVITY)	See Pro- cedure	Tune L4 on 1st OSC/MULT and L1 on MULT SELECTIVITY for maximum meter reading. Tune L2 for minimum meter reading. Change voltage scale if necessary. Then tune L3 for maximum meter reading. Repeat step 3.				
			1	RF AMPLIFIER	S & SELECTIVITY				
4.	A (DISC)	Pin 10		Zero	Apply an on-frequency signal adjacent to L6 (RF SELECTIVITY). Adjust the signal generator for discriminator zero.				
5.	B 2nd IF AMP	Pin 2	L7, L6, L4, L3 and L2 (RF SELECTIVITY) L5 (2nd RF AMP)	Maximum	Apply an on-frequency signal and tune as shown below, keeping signal below saturation.				
	ADIE		20 (2nd in init)		Apply Signal Generator Probe To:				
					L6 L7 L6 and L5 L1 (1st RF AMP) L4, L3 and L2				
6.	B 2nd IF AMP	Pin 2	C341, C342 (RF SELECTIVITY) and L1 (1st RF AMP)	Maximum	Apply an on-frequency signal to antenna jack J441. Tune C341, ${\tt C342}$ an L1 for maximum meter reading, keeping signal below saturation.				
7.	"	u u	L7, L6, L4, L3, L2, C342 and C341 (RF SELECTIVITY), L5 (2nd RF AMP), L1 (1st RF AMP)	Maximum Apply an on-frequency signal as above, keeping below saturation. T L7, L6, L5, L4, L3, L2, L1, C342 and C341 for maximum meter reading.					
8.	"	11	L3 on MULT SELECTIVITY	Maximum	Apply an on-frequency signal as above, keeping below saturation. Tune L2 and L3 on MULT SELECTIVITY Board for maximum meter reading.				

The 1st and 2nd mixer, and low IF circuits have been aligned at the factory and will normally require no further adjustment. If adjustment is necessary, use the procedure outlined in STEPS 9, 10, and 11. L1 (on 1st Mixer) provides impedance matching for the crystal filter input and should only be tuned when observing IF trace on oscilloscope.

1	NOTE
	Refer to DATAFILE BULLETIN 1000-6 IF Alignment of Two-Way Radio FM Receivers for helpful suggestions on how to determine when IF Alignment is required.

2ND MIXER & LO IF

		L			
9.	B (2nd IF AMP)	Pin 2	L3, L2, L1, T1 (2nd Mixer)	Maximum	Apply on-frequency, unmodulated signal and tune L3, L2, L1 and T1 for maximum meter reading, keeping signal below saturation.
10.			L3, L2, L1, T1 on (2nd Mixer)	and	Connect scope, signal generator, and detector as shown in Figure 5. Set signal generator level for 30-50 $\mu V$ and modulate with 10 kHz at 20 Hz. With detector at the collector of Q3 (2nd mixer board output), tune for double trace as shown on scope pattern.
11.	(DISC)	Pin 10		See Pro- cedure	Check to see that discriminator idling voltage is within $\pm .05$ volt of zero with no signal applied. Check to see that modulation acceptance bandwidth is between $\pm 7$ and 9 kHz.

#### ALIGNMENT PROCEDURE

	METERIN	NG POSITION			
р	GE Test Set	Multimeter - at J442	TUNING CONTROL	METER	PROCEDURE
P	Set	- at J442	TUNING CONTROL	READING	
				NOISE	E BLANKER
	H (BLANKER)	Pin 11 (-) and Pin 16 (+)	L9, L8, L7 and L6 on NOISE BLANKER	Maximum	Apply a signal according to the following table:  Receiver operating frequency
					27-33 MHz 4 MHz below operating freq. 33-42 MHz 4 MHz below operating freq. 42-50 MHz 4 MHz above operating freq.
					Apply signal generator probe to: Tune:  Pin 3 of L8 Pin 3 of L7 Antenna Jack  25-33 MHz (L7, 1st peak) 33-50 MHz (L7 and L6; 1st peak)
	11	"	11	Maximum	Apply signal on blanker frequency to the antenna jack. Retune L6, L L8 and L9 for maximum meter reading.
•	"	11	"	0.1 y	Apply a 1,000-microvolt signal on blanker frequency to antenna jack, Reading should be approximately 0.1 volt.
				FREQUENCY	ADJUSTMENT
	A (DISC)	Pin 10	C9 on 1st OSC (C10, C11 or C12 for multi-frequency	Zero	Apply an on-frequency signal to the antenna jack. Tune C9 for zero discriminator reading. In multi-frequency units, tune C10, C11 or C as required.  NOTE ————————————————————————————————————
					For proper frequency control of the receiver, it is recommended that all frequency adjustments be made when the equipment is at a temperature of approximately 75°F. In no case should frequen adjustments be made when the equipment is outside the temperatu range of 50° to 90°F.

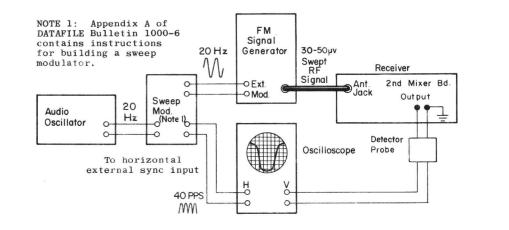


Figure 6 - Test Setup for 20-Hz Double-Trace Sweep Alignment

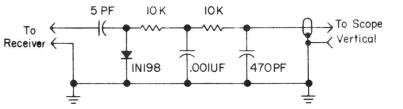


Figure 7 - Detector Probe for Sweep Alignment

## ALIGNMENT PROCEDURE

25—50 MHz MASTR RECEIVER MODELS 4ER39C68-85

LBI-4124

Issue

#### LBI-4124

## TEST PROCEDURES

These Test Procedures are designed to help you to service a receiver that is operating---but not properly. The problems encountered could be low power, poor sensitivity, distortion, limiter not operating properly, and low gain. By following the the defect can be quickly localized. Once

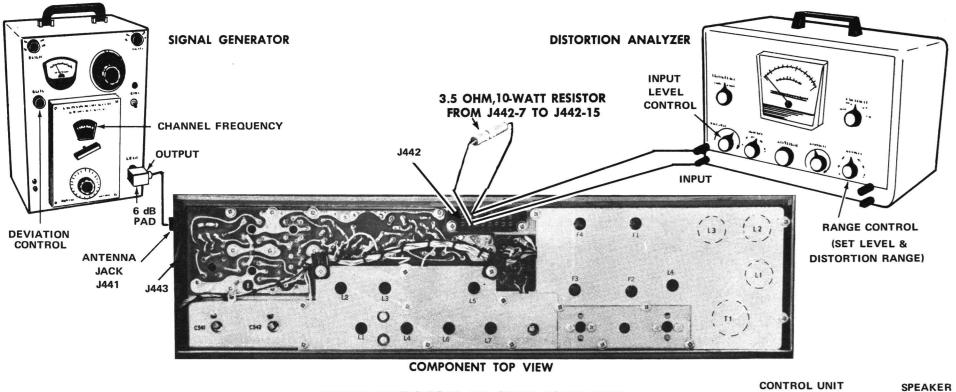
included in the Troubleshooting Procedure. Before starting with the Receiver Test Procedures, be sure the receiver is tuned and sequence of test steps starting with Step 1, aligned to the proper operating frequency.

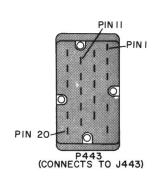
## TEST EQUIPMENT REQUIRED

- Distortion Analyzer similar to: Heath IM-12
- Signal Generator similar to: Measurements M-560
- 6-dB attenuation pad, and 3.5-ohm. 10-watt resistor

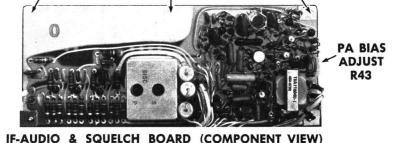
## PRELIMINARY ADJUSTMENTS

- ver as shown for all steps of the receiver Test Procedure.
- for all steps of the Test Procedure.
- 3. Turn on all of the equipment and let it warm up for 20 minutes.





REMOVE THREE SCREWS AND SWING BOARD OPEN



PIN 2 REMOVED FROM PLUG P701

the defective stage is pin-pointed, refer to

problem. Additional corrective measures are

the "Service Check" listed to correct the

## 1. Connect the test equipment to the recei-

- 2. Turn the SQUELCH control fully clockwise

## STEP 1 **AUDIO POWER OUTPUT AND DISTORTION**

#### **TEST PROCEDURE**

Measure Audio Power Output as follows:

- A. Apply a 1,000-microvolt, on-frequency test signal modulated by 1,000 hertz with ±3.0 kHz deviation to antenna jack J441.
- B. With Five-Watt Speaker:

Disconnect speaker lead pin from J701-2 (on rear of Control Unit).

Connect a 3.5-ohm load resistor from J442-15 to J442-7. Connect the Distortion Analyzer input across the resistor as shown.

#### With Handset:

Lift the handset off of the hookswitch. Connect the Distortion Analyzer input from J442-15 to J442-7.

- C. Adjust the VOLUME control for five-watt output (4.18 VRMS using the Distortion Analyzer as a VTVM).
- Make distortion measurements according to manufacturer's instructions. Reading should be less than 5%. If the receiver sensitivity is to be measured, leave all controls and equipment as they are.

#### SERVICE CHECK

If the distortion is more than 5%, or maximum audio output is less than five watts, make the following checks:

- Battery and regulator voltage---low voltage will cause distortion. (Refer to Receiver Schematic Diagram for voltages.)
- P.A. Bias Adjust (R43) -- Turn the SQUELCH control fully counterclockwise.

Then connect a milliammeter in series with the +12 volt lead at P443-11. With no signal in, adjust R43 for a reading of approximately 20 milliamps. This adjustment should not be necessary unless an output transistor has been rereplaced.

- G. Audio Gain (Refer to Receiver Troubleshooting Procedure).
- Discriminator Alignment (Refer to Receiver Alignment on reverse side of page).

## STEP 2 **USABLE SENSITIVITY** (12-dB SINAD)

If STEP 1 checks out properly, measure the receiver sensitivity as follows:

- A. Apply a 1000-microvolt, on-frequency signal modulated by 1000 Hz with 3.0-kHz deviation to J441.
- Place the RANGE switch on the Distortion Analyzer in the 200 to 2000-Hz distortion range position (1000-Hz filter in the circuit). Tune the filter for minimum reading or null on the lowest possible scale (100%, 30%, etc.)
- C. Place the RANGE switch to the SET LEVEL position (filter out of the circuit) and adjust the input LEVEL control for a +2 dB reading on a mid range (30%).
- While reducing the signal generator output, switch the RANGE control from SET LEVEL to the distortion range until a 12-dB difference (+2 dB to -10 dB) is obtained between the SET LEVEL and distortion range positions (filter out and filter in).
- E. The 12-dB difference (Signal plus Noise and Distortion to noise plus distortion ratio) is the "usable" sensitivity level. The sensitivity should be less than 0.25 microvolts with an audio output of at least 2.5 watts (2.9 volts RMS across the 3.5-ohm receiver load using the Distortion Analyzer as a VTVM).

F. Leave all controls as they are and all equipment connected if the Modulation Acceptance Bandwidth test is to be per-

#### SERVICE CHECK

If the sensitivity level is more than 0.25 microvolts, check the alignment of the RF stages as directed in the Alignment Procedure, and make the gain measurements as shown on the Troubleshooting Procedure.

## STEP 3 **MODULATION ACCEPTANCE BANDWIDTH (IF BANDWIDTH)**

If STEPS 1 and 2 check out properly. measure the bandwidth as follows:

- A. Set the Signal Generator output for twice the microvolt reading obtained in the 12-dB SINAD measurement.
- Set the RANGE control on the Distortion Analyzer in the SET LEVEL position (1000-Hz filter out of the circuit), and adjust the input LEVEL control for a +2 dB reading on the 30% range.
- While increasing the deviation of the Signal Generator, switch the RANGE control from SET LEVEL to distortion range until a 12-dB difference is obtained between the SET LEVEL and distortion range readings (from +2 dB to -10 dB).
- The deviation control reading for the 12-dB difference is the Modulation Acceptance Bandwidth of the receiver. It should be more than ±7 kHz (but less than ±9 kHz)

#### SERVICE CHECK

If the Modulation Acceptance Bandwidth test does not indicate the proper width, make gain measurements as shown on the Receiver Troubleshooting Procedure.

### TROUBLESHOOTING PROCEDURE

Before starting the Noise Blanker troubleshooting procedure, make sure the receiver is operating properly. Align the Noise Blanker as described on the ALIGNMENT PROCEDURE Sheet. Then make the following Troubleshooting checks:

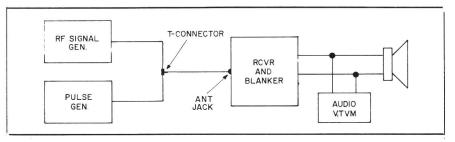
#### STEP 1—PERFORMANCE CHECK

Equipment Required:

- RF Signal Generator coupled through a 6 dB pad.
- Pulse Generator with repetition rate and level controls (similar to General Electric
- AC VTVM

Procedure:

1. Connect Pulse Generator and RF Signal Generator to receiver antenna jack through a T-connector and connect VTVM to receiver output as shown in Figure 1.



RC-1388

Figure 1 - Equipment Connection Diagram

- 2. Apply an unmodulated RF Signal and check the 20 dB quieting sensitivity of the receiver. (Measure with Model 4EX4A10 Pulse Generator connected but turned off).
- 3. Disable pulse section of the noise blanker by shorting Q4 base to emitter. (A yellow dot is located between the base and emitter connections on solder side of the noise blanker board).
- 4. Set the pulse generator (Model 4EX4A10) repetition rate to 1500 Hz and adjust the output level control on pulse generator until receiver sensitivity is degraded as much as possible (approximately 45 dB).
- 5. Remove base-emitter short from Q4. The receiver sensitivity should restore to within 5 dB of 20 dB quieting level obtained in step 2 above.

#### STEP 2—QUICK CHECKS

Equipment Required:

- Audio Voltmeter (VTVM) • Audio Oscillator (sine wave)

SYMPTOMS	PROCEDURE
No regulated 10-volts	Check the 12-volt supply. Then check regulator circuit. (Refer to troubleshooting procedure for power supply.
No blanking	Check waveforms (STEP 3) and voltage ratios (STEP 4).
Partial or no blanking	a. Check RF attenuation as follows: Connect signal generator to Antenna Jack. Adjust the output of the signal generator for 0.2 volts on the 2nd IF amplifier (position B on test set) and note the signal generator reading. Short the Q5 base to emitter pattern (identified by red ink dot) and increase the signal generator output until the same 2nd IF amplifier reading is obtained. Signal level must increase 60 dB or more.
	b. Check repetition rate switch. Connect a 6-kHz sine wave signal from audio oscillator through a 0.33-µF capacitor to point "A" located on the noise blanker board. Adjust the output of the audio oscillator for 2-volts, peak-to-peak. Observe the output of the pulse generator (on noise blanker) with an oscilloscope. The repetition rate of the pulse generator should not increase over 2 kHz or decrease under 1 kHz. (This is true for sine wave inputs like intermodulation in the blanker channel but not for strong impulse noise from antenna.)
	c. Check vehicle ignition system. Worn-out points, bad spark plugs, or breaks in ignition wiring can cause a "dirty" ignition pulse to be generated causing the blanker to operate incorrectly.

#### STEP 4—VOLTAGE RATIO READINGS

#### Equipment Required:

- RF Voltmeter (similar to Boonton Model 91-CA
- or Millivac Type MV-18 C)

- 1. Apply probe to input of stage (for example, base of 1st RF Amp). Peak resonant circuit of stage being measured and take voltage reading (E1).
- 2. Move probe to input of following stage (2nd RF Amp. Repeak first resonant circuit. Then peak circuit being measured and take reading (E2).
- 3. Convert readings by means of the following formula.

Voltage Ratio = 
$$\frac{E_2}{E_1}$$

4. Check results with typical voltage ratios shown on diagram for each stage.

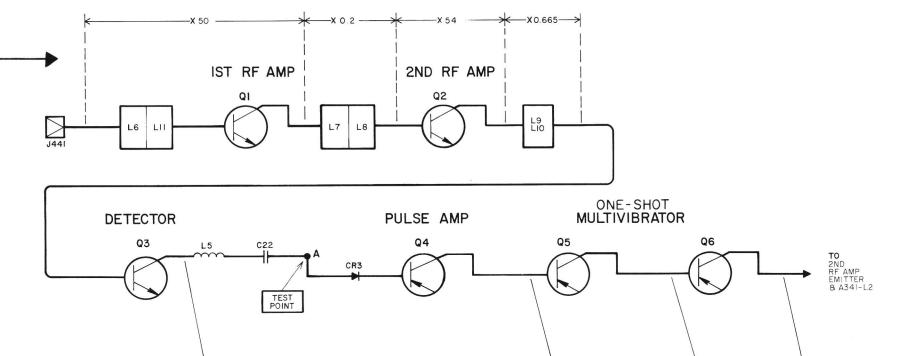
#### STEP 3—WAVE FORMS

#### Equipment Required:

- Oscilloscope
- Noise Generator

#### Procedure:

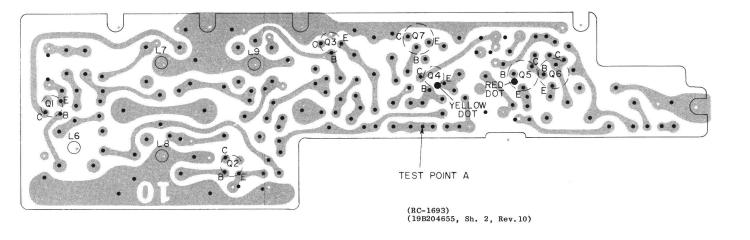
Adjust noise generator for maximum output level and observe waveforms on oscilloscope at the indicated points.



8-14 µSEC

NOISE BLANKER

-7 TO -9V P-P



(RC-1281B)

Denotes Solder Side

5-10 µSEC

## TROUBLESHOOTING PROCEDURE

LBI-4124

NOISE BLANKER FOR 25—50 MHz RECEIVER TYPE ER-39-C

Issue 3

12-18 µSEC

12-18 µSEC

## TROUBLESHOOTING PROCEDURE

Before starting the Noise Blanker troubleshooting procedure, make sure the receiver is operating properly. Align the Noise Blanker as described on the ALIGNMENT PROCEDURE Sheet. Then make the following Troubleshooting checks:

#### STEP 1—PERFORMANCE CHECK

Equipment Required:

- RF Signal Generator coupled through a 6 dB pad.
- Pulse Generator with repetition rate and level controls (similar to General Electric Model 4EX4A10)
- AC VTVM

Procedure:

1. Connect Pulse Generator and RF Signal Generator to receiver antenna jack through a T-connector and connect VTVM to receiver output as shown in Figure 1.

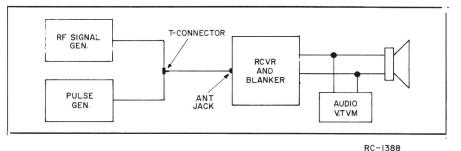


Figure 1 - Equipment Connection Diagram

- 2. Apply an unmodulated RF Signal and check the 20 dB quieting sensitivity of the receiver. (Measure with Model 4EX4A10 Pulse Generator connected but turned off).
- 3. Disable pulse section of the noise blanker by shorting Q4 base to emitter. (A yellow dot is located between the base and emitter connections on solder side of the noise blanker board).
- 4. Set the pulse generator (Model 4EX4Al0) repetition rate to 1500 Hz and adjust the output level control on pulse generator until receiver sensitivity is degraded as much as possible (approximately 45 dB).
- 5. Remove base-emitter short from Q4. The receiver sensitivity should restore to within 5 dB of 20 dB quieting level obtained in step 2 above.

#### STEP 2—QUICK CHECKS

Equipment Required:

- Audio Voltmeter (VTVM)
- Audio Oscillator (sine wave)

SYMPTOMS	PROCEDURE
No regulated 10-volts	Check the 12-volt supply. Then check regulator circuit. (Refer to troubleshooting procedure for power supply.
No blanking	Check waveforms (STEP 3) and voltage ratios (STEP 4).
Partial or no blanking	a. Check RF attenuation as follows: Connect signal generator to Antenna Jack. Adjust the output of the signal generator for 0.2 volts on the 2nd IF amplifier (position B on test set) and note the signal generator reading. Short the Q5 base to emitter pattern (identified by red ink dot) and increase the signal generator output until the same 2nd IF amplifier reading is obtained. Signal level must increase 60 dB or more.
	b. Check repetition rate switch. Connect a 6-kHz sine wave signal from audio oscillator through a 0.33-µF capacitor to point "A" located on the noise blanker board. Adjust the output of the audio oscillator for 2-volts, peak-to-peak. Observe the output of the pulse generator (on noise blanker) with an oscilloscope. The repetition rate of the pulse generator should not increase over 2 kHz or decrease under 1 kHz. (This is true for sine wave inputs like intermodulation in the blanker channel but not for strong impulse noise from antenna.)
	c. Check vehicle ignition system. Worn-out points, bad spark plugs, or breaks in ignition wiring can cause a "dirty" igni- tion pulse to be generated causing the blanker to operate in- correctly.

#### STEP 4—VOLTAGE RATIO READINGS

Equipment Required:

- RF Voltmeter (similar to Boonton Model 91-CA
- or Millivac Type MV-18 C)

Procedure:

- 1. Apply probe to input of stage (for example, base of 1st RF Amp). Peak resonant circuit of stage being measured and take voltage reading (E1).
- 2. Move probe to input of following stage (2nd RF Amp).
  Repeak first resonant circuit. Then peak circuit being measured and take reading (E2).
- 3. Convert readings by means of the following formula.

Voltage Ratio = 
$$\frac{E_2}{E_1}$$

4. Check results with typical voltage ratios shown on diagram for each stage.

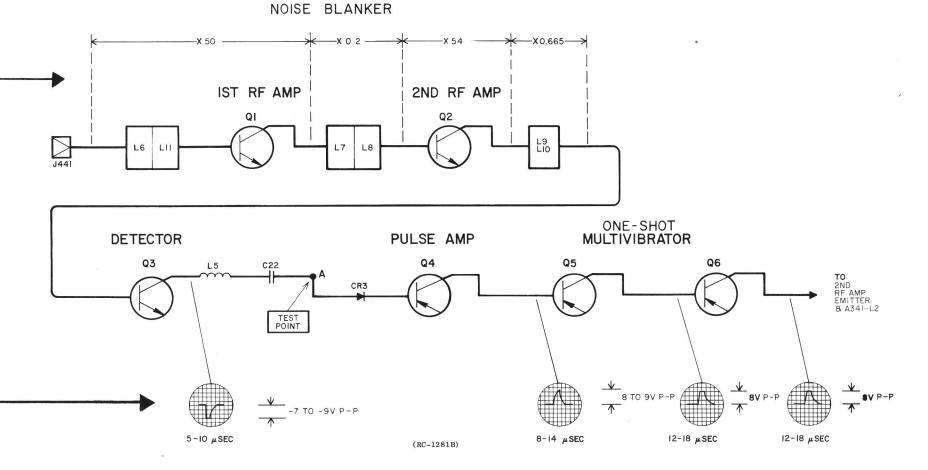
#### STEP 3—WAVE FORMS

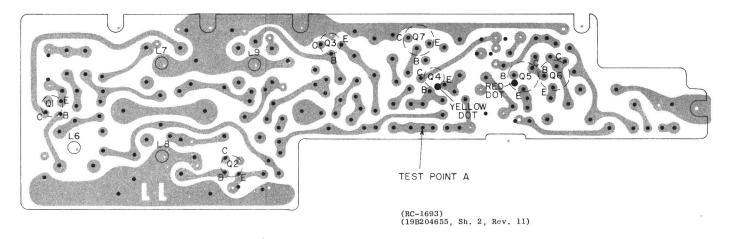
Equipment Required:

- Oscilloscope
- Noise Generator

#### Procedure:

Adjust noise generator for maximum output level and observe waveforms on oscilloscope at the indicated points.





Denotes Solder Side

## TROUBLESHOOTING PROCEDURE

NOISE BLANKER FOR 25-50 MHz RECEIVER TYPE ER-39-C

Issue 4

## STEP 1 - QUICK CHECKS

#### **TEST SET CHECKS**

These checks are typical voltage readings measured with GE Test Set Model 4EX3AlO in the Test 1 position, or Model 4EX8KlO or 11 in the 1-volt position.

Metering Position	Reading With No Signal In	Reading with 1 Micro- volt Unmodulated
A (Disc Idling)	Less then ±.05 VDC	
B (2nd IF)	.15 VDC	.7 VDC
C (1st Lim)	.7 VDC	0.8 VDC
D (Mult-1)	0.6 VDC	
J (Reg. +10 volts)	+10 VDC	

#### SYMPTOM CHECKS

SYMPTOM	PROCEDURE
NO SUPPLY VOLTAGE	<ul> <li>Check power connections and continuity of supply leads, and check fuse in power supply. If fuse is blown, check receiver for short circuits.</li> </ul>
NO REGULATED 10-VOLTS	• Check the 12-volt supply. Then check regulator circuit. (See Troubleshooting Procedure for Power Supply).
LOW 1ST LIM READING	• Check supply voltages and then check oscillator reading at J442-4 & 5 as shown in STEP 2A.
	Make SIMPLIFIED VTVM GAIN CHECKS from 2nd Mixer through 1st Limiter stages as shown in STEP 2A.
LOW OSCILLATOR/MULTI- PLIER READINGS	<ul> <li>Check alignment of Oscillator, (Refer to Front End Alignment Procedure).</li> </ul>
	<ul> <li>Check voltage readings of 1st Oscillator/Multi- plier Q1/Q2.</li> </ul>
	• Check crystal Yl.
LOW RECEIVER SENSITIV-	<ul> <li>Check Front End Alignment. (Refer to Receiver Alignment Procedure).</li> </ul>
	• Check antenna connections, cable and relay.
	• Check 1st and 2nd Oscillator injection voltage.
	<ul> <li>Check voltage readings of 1st Mixer, HI IF Amp and 2nd Mixer.</li> </ul>
	• Make SIMPLIFIED GAIN CHECKS (STEP 2A).
LOW AUDIO	<ul> <li>Check Audio PA (Q341 &amp; Q342) voltage readings on schematic diagram.</li> </ul>
	<ul> <li>Make simplified gain and waveform checks of audio and squelch stages. (Steps 2A and 2B).</li> </ul>
	<ul> <li>Make unsquelched voltage readings in Audio section. (Refer to Receiver Schematic Diagram).</li> </ul>
	<ul> <li>Check voltage readings on Channel Guard board.</li> </ul>
HIGH DISTORTION AT LOW AUDIO LEVELS (50 MW)	<ul> <li>Set PA bias adjust R43 as specified under Service Checks in STEP 1 of TEST PROCEDURES.</li> </ul>
IMPROPER SQUELCH OPERA- TION	<ul> <li>Check voltage readings of Squelch circuit. (Refer to Receiver Schematic Diagram).</li> </ul>
	<ul> <li>Make gain and waveform checks of audio and squelch stages. (Steps 2A and 2B).</li> </ul>
DISTORTION IDLING TOO FAR OFF ZERO	<ul> <li>See if discriminator zero is in center of IF bandpass.</li> </ul>

## STEP 3-VOLTAGE RATIO READINGS

#### EQUIPMENT REQUIRED:

- 1. RF Voltmeter (similar to Boonton Model 91-CA or Millivac Type MV-18 C.
- Signal on receiver frequency (below saturation). Correct frequency can be determined by zeroing the discriminator. Use 1,000 hertz signal with 3.0 kHz deviation.

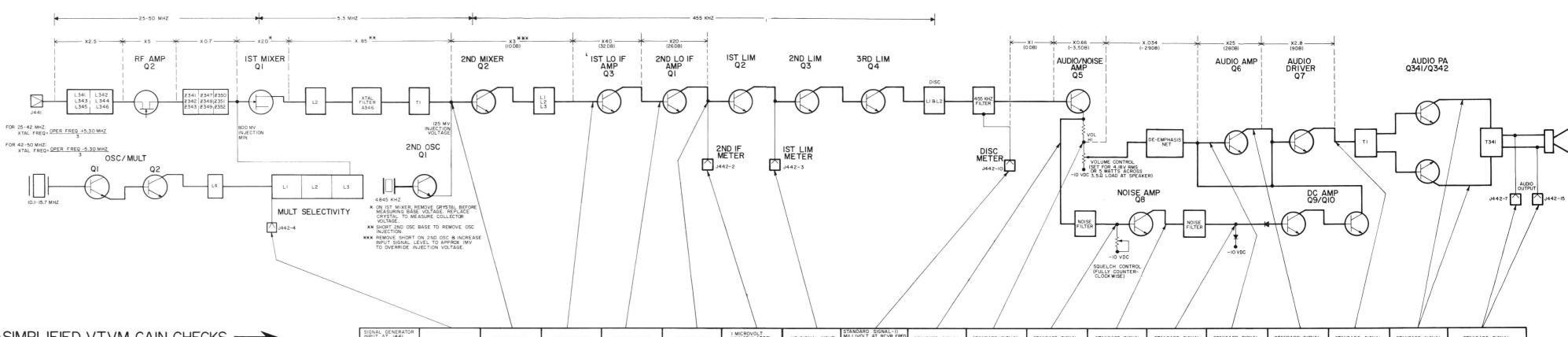
#### PROCEDURE:

- 1. Apply probe to input of stage (for example, base of RF amp).

  Peak resonant circuit of stage being measured and take voltage reading (E1).
- Move probe to input of following stage (lst mixer\*). Repeak first resonant circuit then peak circuit being measured and take reading (E2).
- 3. Convert readings by means of the following formula.

Voltage Ratio = 
$$\frac{E_2}{E_1}$$

4. Check results with typical voltage ratios shown on diagram.



(RC-1992)

## STEP 2A-SIMPLIFIED VTVM GAIN CHECKS -

#### EQUIPMENT REQUIRED:

- 1. VTVM AC & DC
- 2. Signal generator (Measurements M560 to equivalent).

#### PRELIMINARY STEPS:

- Set VOLUME control for 4.18 volts across 3.5-ohm load. If this cannot be obtained, set to approx. 70% of max. rotation.
- 2. Set SQUELCH control fully counterclockwise.
- 3. Receiver should be properly aligned.
- 4. Connect VTVM between system negative and points indicated by arrow.

SIGNAL GENERATOR INPUT AT J441 MAINTAIN SETTING AT DISCRIMINATOR ZERO		UNMODULATED	UNMODUL ATED	UNMODUL ATED	UNMODULATED	I MICROVOLT UNMODULATED	NO SIGNAL INPUT	STANDARD SIGNAL-(I MILLIVOLT AT RCVR FREQ, MODULATED BY IKHZ WITH 3.3 KHZ DEVIATION)	STANDARD SIGNAL									
PROCEDURE		READING ON 1.5 V	FROM ZERO UNTIL VTVM READING DE-	FROM ZERO UNTIL VTVM READING DE-	INCREASE SIGNAL GENERATOR OUTPUT FROM ZERO UNTIL VTVM READING DE- CREASES BY 5 %													CONNECT VTVM OR SCOPE ACROSS 3.5 $\Omega$ LOAD BETWEEN J442-7 AND J442-15 WITH SPEAKER DISCONNECTED.
READING	2.4 VDC	GENERATOR OUTPUT SHOULD BE APPROX 20 MILLIVOLTS	GENERATOR OUTPUT SHOULD BE APPROX 600 MICROVOLTS	GENERATOR OUTPUT SHOULD BE APPROX 5 MICROVOLTS	GENERATOR OUTPUT SHOULD BE APPROX 0.3 MICROVOLTS	-0.6 VDC	- 2 VDC	O.8 VAC	0.75 VAC	0.55 VAC	0.15 VAC	2.3 VAC	0.05 VAC		O.5 VAC	I.4 VAC	IO VAC	4.18 VAC

## STEP 2B-AUDIO & SQUELCH WAVEFORMS ->

#### EQUIPMENT REQUIRED:

- Oscilloscope.
- 2. Signal generator (Measurements M560 to equivalent).

#### PRELIMINARY STEPS:

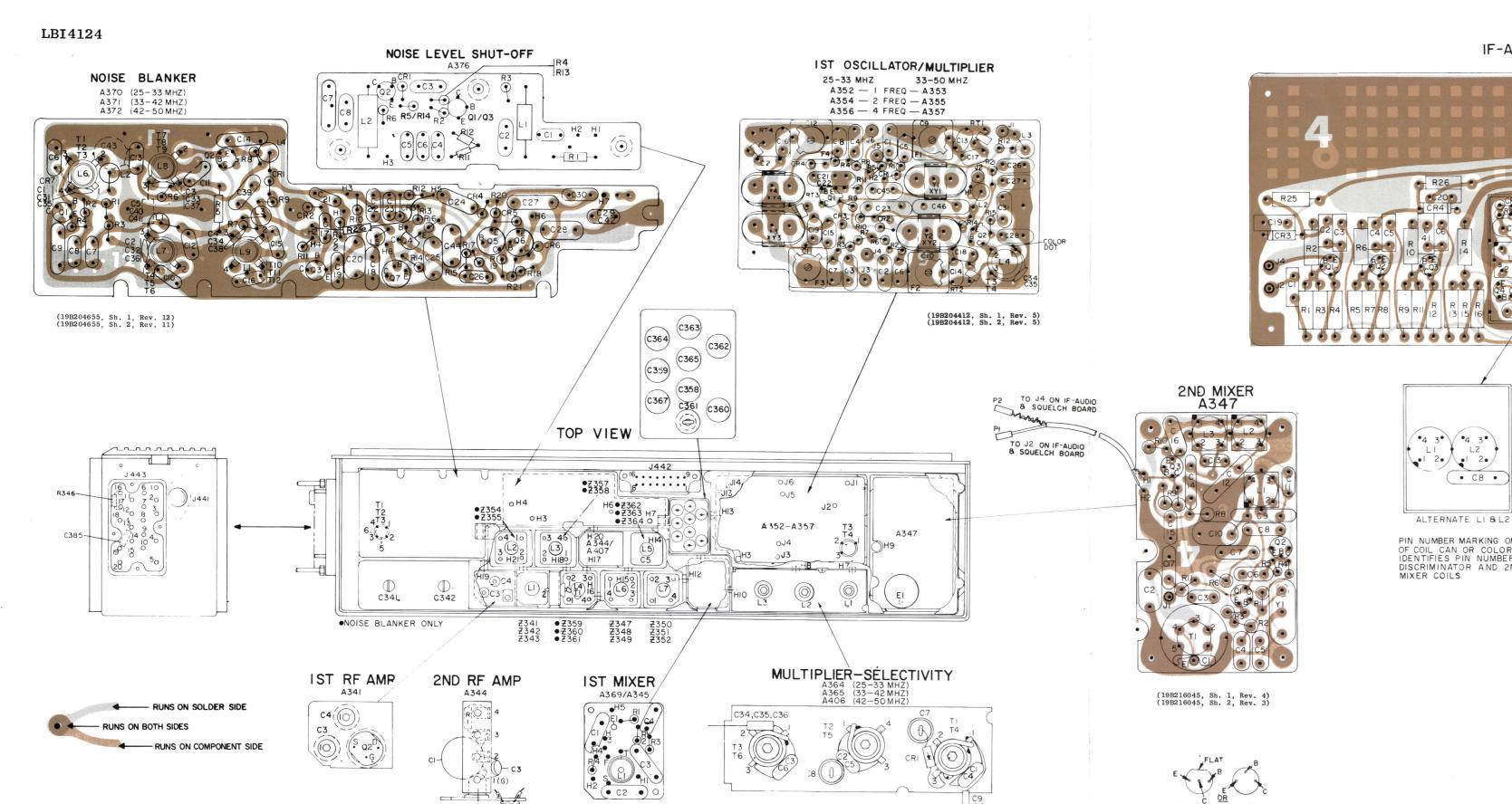
- 1. Set VOLUME control for 4.18 volts across 3.5-ohm load. If this cannot be obtained, set to approx. 70% of max. rotation.
- 2. Set SQUELCH control fully counterclockwise.
- 3. Receiver should be properly aligned.
- 4. Connect oscilloscope between system negative and points indicated by arrow.

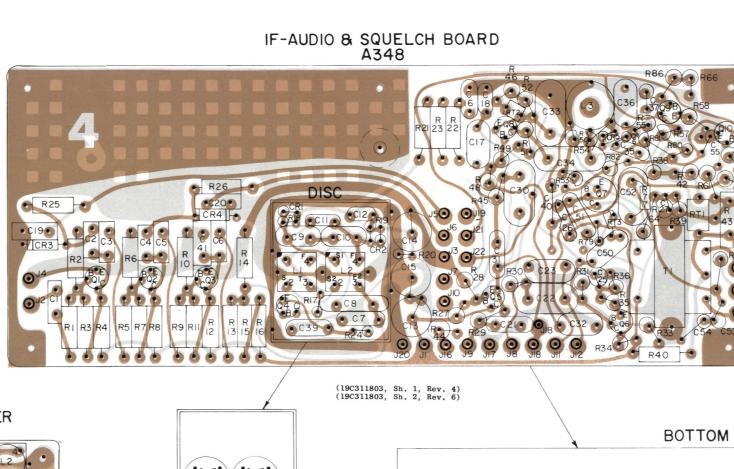
## O.5 MS/DIV 0.5 MS/DIV STANDARD SIGNAL NOISE WAVE FORM

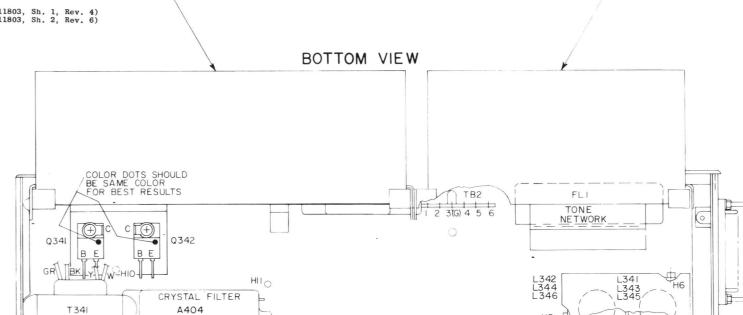
## TROUBLESHOOTING PROCEDURE

25—50 MHz, MASTR RECEIVER MODELS 4ER39C68-85

Issue 1





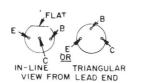


CHANNEL GUARD

TONE REJECT FILTER
A402 (CONSISTS OF

(19C311794, Sh. 1, Rev. 4) (19C311794, Sh. 2, Rev. 4)

ALTERNATE LI 8 L2 PIN NUMBER MARKING ON SIDE OF COIL CAN OR COLOR DOT IDENTIFIES PIN NUMBER I ON DISCRIMINATOR AND 2ND MIXER COILS



NOTE: LEAD ARRANGEMENT, AND NOT CASE SHAPE, IS DETERMINING FACTOR FOR LEAD IDENTIFICATION. TRANSISTOR LEAD IDENTIFICATION

(19R621253, Rev. 26)

**OUTLINE DIAGRAM** 

25-50 MHz, MASTR RECEIVER MODELS 4ER39C68-85

(NOISE BLANKER ONLY)

## PARTS LIST LB14134G

25-50 MHz RECEIVER MODELS 4ER39C68 - 4ER39C85

SYMBOL	GE PART NO.	DESCRIPTION
A341		RF AMPLIFIER ASSEMBLY 19B204772G3
C3 and C4	5493392P7	Ceramic, feed-thru: 1000 pf +100% -0%, 500 VDCW sim to Allen-Bradley Type FA5C.
C9 and C10	5494481P11	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.
Ll	7491382P101	Coil, RF: 100 µh ±10%, 4 ohms DC res max; sim to Delevan 3500 Series.
Q2*	19A116960P1	N Type, field effect; sim to Type 2N4416.
	19A115953P1	In 19E500873G4 of REV P & earlier: In 19E500873G5, G6 of REV M & earlier:
	10411000571	N channel, field effect.
		RESISTORS
R10	3R152P470J	Composition: 47 ohms ±5%, 1/4 w.
R11 and R12	3R152P101J	Composition: 100 ohms ±5%, 1/4 w.
XQ2	5490277P5	Transistor, phen: 3 contacts; sim to Alcon 1213LL2.
A344		RF AMPLIFIER 19B204770G1
Cl	5494481P14	Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.
C3*	5494481P11	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap. Added to 19E500873G4 by REV M. Added to 19E500873G5, G6 by REV L.
		DIODES AND RECTIFIERS
CR1*	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV. Deleted in 19E500873G4 by REV M. Deleted in 19E500873G5, G6 by REV L.
		In 19E500873G4 of REV G & earlier: In 19E500873G5, G6 of REV F & earlier:
	4038056P1	Germanium, fast recovery, Reverse 20 volts, Fwd current 40 mA.
Q1	19A115342P1	Silicon, NPN.
	1	
R1*	3R152P202J	Composition: 2K ohms ±5%, 1/4 w.
		In 19E500873G4 of REV L & earlier: In 19E500873G5, G6 of REV K & earlier:
	3R152P510J	Composition: 51 ohms ±5%, 1/4 w.
TB1	7487424P19	TERMINAL BOARDS Miniature, phen: 3 terminals.
A347		SECOND MIXER 19821611961
	1	

YMBOL	GE PART NO.	DESCRIPTION
С3	5494481P112	Ceramic disc: 1000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.
C4 and C5	5490008P35	Silver mica: 220 pf ±5%, 500 VDCW; sim to Electro Motive Type DM-15.
C6	5490008P9	Silver mica: 18 pf ±5%, 500 VDCW; sim to Electro Motive Type DM-15.
C7 and C8	19A116080P5	Polyester: 0.047 µf ±20%, 50 VDCW.
С9	5496219P369	Ceramic disc: 180 pf ±5%, 500 VDCW, temp coef -150 PPM.
C10	19A116080P7	Polyester: 0.1 µf ±20%, 50 VDCW.
C11	5496219P40	Ceramic disc: 9 pf ±0.25 pf, 500 VDCW, temp coef 0 PPM.
C12	5496219P369	Ceramic disc: 180 pf ±5%, 500 VDCW, temp coef -150 PPM.
C13	5496219P40	Ceramic disc: 9 pf ±0.25 pf, 500 VDCW, temp coef 0 PPM.
C14	19A116656P220J2	Ceramic disc: 220 pf ±5%, 500 VDCW, temp coef -220 ppM.
C15	7491395P109	Ceramic disc: 1000 pf ±10%, 500 VDCW; sim to RMC Type JL.
C16	19A116080P5	Polyester: 0.047 µf ±20%, 50 VDCW.
C17	19A116080P1	Polyester: 0.01 µf ±20%, 50 VDCW.
		JACKS AND RECEPTACLES
Jl	4033513P4	Contact, electrical; sim to Bead Chain L93-3.
		INDUCTORS
Ll	19C311181G3	Coil. Includes:
	4038368P1	Tuning slug.
L2 and L3	19A115711P1	Transformer, freq: 455 KHz; sim to Automatic Mfg EX12670.
Pl	4029840P2	Contact, electrical: sim to Amp 42827-2.
P2	4029840P1	Contact, electrical: sim to AMP 41854.
Q1	19A115889P1	TRANSISTORS
Q2	19A115245P1	Silicon, NPN. Silicon, NPN.
Q3	19A115123P1	Silicon, NPN.
,-		
		RESISTORS
R1 and R2	3R77P103K	Composition: 10K ohms ±10%, 1/2 w.
R3	3R77P512J	Composition: 5.1K ohms ±5%, 1/2 w.
R4	3R152P333K	Composition: 33K ohms ±10%, 1/4 w.
R5	3R152P103J	Composition: 10K ohms ±5%, 1/4 w.
R6	3R77P332K	Composition: 3.3K ohms ±10%, 1/2 w.
R7	3R77P123K	Composition: 12K ohms ±10%, 1/2 w.
R8	3R77P622J	Composition: 6.2K ohms ±5%, 1/2 w.
R9	3R77P302J	Composition: 3K ohms ±5%, 1/2 w.
R10	3R77P202J	Composition: 2K ohms ±5%, 1/2 w.
R11	3R77P201J	Composition: 200 ohms ±5%, 1/2 w.
- 1		
Tl		COIL ASSEMBLY 19B216120G1
Cl	19C301540P261	Ceramic disc: 82 pf ±5%, 200 VDCW, temp coef -80 PPM.
	5491798P3	Tuning slug.
	.	
	j.	1

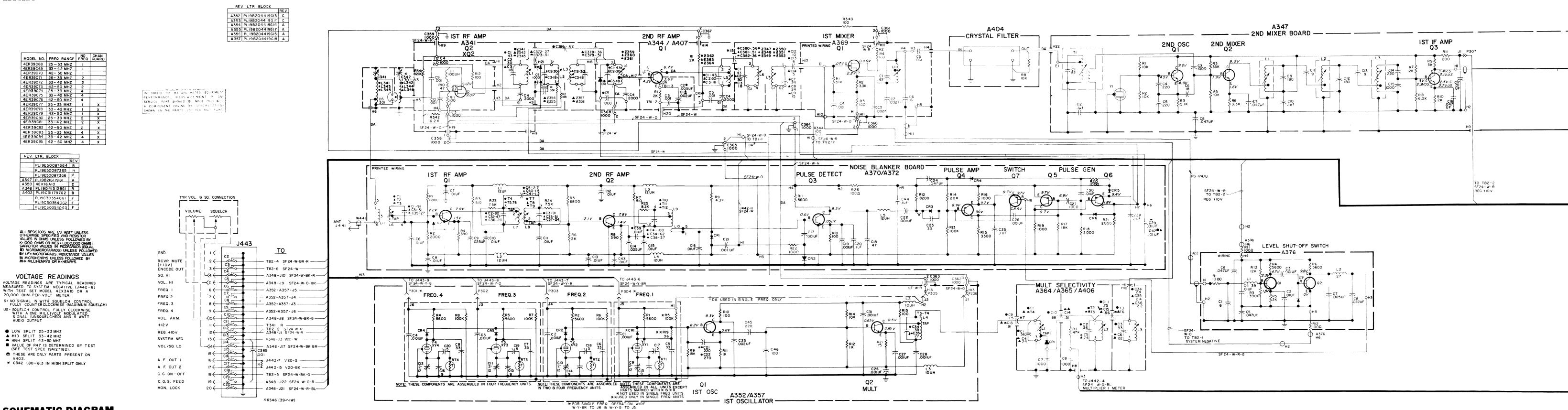
SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.
			C39	19A116080P1
Y1	19A110192P3	Quartz: freq 4845 KHz ±100 Hz at 25°C, temp range -30°C to +75°C.	C40*	5496267P29
A348		IF AUDIO AND SQUELCH 19D413129G1		5496267P28
			943	
c1	5494481P111	Ceramic disc: 1000 pf $\pm 20\%$ , 1000 VDCW; sim to RMC Type JF Discap.	C41	5490008P129
C <b>2</b>	5496219P717	Ceramic disc: 47 pf ±10%, 500 VDCW, temp coef -750 PPM.	C50 C51	19A116080P7 19A116655P22
с3	5494481P111	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.	C52	19A116080P109
C4	5496219P717	Ceramic disc: 47 pf ±10%, 500 VDCW, temp coef -750 PPM.	C53 and	5496267P213
c5 and c6	5494481P111	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.	C54 C55	5496267Pl4
c6 c7	19A116080P5	Polyester: 0.047 µf ±20%, 50 VDcW.		
c8	19A116656P180J1	Ceramic disc: 180 pr ±5%, 500 VDCW, temp coef -150 PPM.	CR1	19A115250P1
С9	5490008P37	Silver mica: 270 pf ±5%, 500 VDCW; sim to	and CR2	19411323091
and C10		Electro Motive Type DM-15.	CR3*	19A115250P1
C11	5496219P656	Ceramic disc: 51 pf $\pm 5\%$ , 500 VDCW, temp coef $-470$ PPM.	CR4*	
C12	5494481P108	Ceramic disc: 470 pf $\pm 10\%$ , 1000 VDCW; sim to RMC Type JF Discap.		4038056P1
c13	19A115680P107	Electrolytic: 100 $\mu f$ +150% -10%, 15 VDCW; sim to Mallory Type TT.	CR5 and	19A115250P1
C14 and C15	19A115680P104	Electrolytic: 50 $\mu f$ +150% -10%, 25 VDCW; sim to Mallory Type TT.	CR6	
c16	5494481P112	Ceramic disc: 1000 pf $\pm 10\%$ , 500 VDCW; sim to RMC Type JF Discap.	J1 thru J22	4033513P4
C17	19A116080P7	Polyester: 0.1 μf ±20%, 50 VDCW.		
c18	5494481P108	Ceramic disc: 470 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.	L1	19A115711P6
C19 and C20	19A116080P5	Polyester: 0.047 μf ±20%, 50 VDCW.	L2	19A115711P7
C21	19A116080P3	Polyester: 0.022 μf ±20%, 50 VDCW.	L3	19A127134G1 7486872P7
C <b>22</b>	19A116080P108	Polyester: 0.15 µf ±10%, 50 VDCW.		140001221
C <b>23</b>	19A116080P107	Polyester: 0.1 µf ±10%, 50 VDCW.		
C25	5496267P6	Tantalum: 33 µf ±20%, 10 VDCW; sim to Sprague Type 150D.	Q1 thru Q4	19A115123P1
C26*	19A116080P110	Polyester: 0.33 µf ±10%, 50 VDCW.	Q5*	19A115889P1
	19A116080P109	In REV E-M: Polyester: 0.22 µf ±10%, 50 VDCW.		
		In REV D and earlier:		19A115123P1
l	5496267P28	Tantalum: 0.47 µf ±20%, 35 VDcW; sim to	Q6	19A115123P1
C27*	5496267P2	Sprague Type 150D.  Tantalum: 47 µf ±20%, 6 VDCW: sim to	Q7 Q8	19A115300P4 19A115123P1
32.	0.5020.1.2	Sprague Type 150D.	Q9	19A115362Pl
	5496267P6	In REV B and earlier: Tantalum: 33 µf ±20%, 10 VDcW; sim to	Q10*	19A116774P1
c30	19A116080P8	Sprague Type 150D.  Polyester: 0.15 µf ±20%, 50 VDCW.		19A115123P1
C31	19A116080P102	Polyester: 0.015 µf ±10%, 50 VDcw.	1	10111012011
C32	19A116080P7	Polyester: 0.1 µf ±20%, 50 VDCW.		
c33	19A116080P9	Polyester: 0.22 µf ±20%, 50 VDCW.	R1	3R77P102K
C <b>34</b>	4029003P207	Silver mica: 1830 pf ±2%, 500 VDCW; sim to	R2	3R77P153J
c35	19A116080P5	Electro Motive Type DM-20.	R3 R4	3R77P823K 3R77P472K
C36*	19A116080P5	Polyester: 0.047 µf ±20%, 50 VDCW.  Polyester: 0.22 µf ±20%, 50 VDCW.	R5	3R77P472K 3R77P102K
330	-5/122000F3	In REV B and earlier:	R6	3R77P153J
	19B209243P7	Polyester: 0.1 µf ±20%, 50 VDCW.	R7	3R77P823K
	* * *		1 1	
C37	5496267P28	Tantalum: 0.47 μf ±20%, 35 VDCW; sim to	R8	3R77P472K
c37	5496267P28	Tantalum: 0.47 µf ±20%, 35 VDCW; sim to Sprague Type 150D.	R9	3R77P472K 3R77P102K

DESCRIPTION	SYMBOL	GE
Polyester: 0.01 µf ±20%, 50 VDCW.	R11	3R771
Tantalum: 0.68 µf ±20%, 35 VDCW; sim to Sprague	R12	3R771
Type 150D.	R13	3R771
In REV K & earlier:	R14	3R771
Tantalum: 0.47 µf ±20%, 35 VDCW; sim to Sprague Type 150D.	R15	3R771
Silver mica: 120 pf ±10%, 500 VDCW; sim to	R16	3R771
Electro Motive Type DM-15.	R17	3R15
Polyester: 0.1 \( \text{\psi} \) f \( \pm 20\%, \) 50 VDCW.  Ceramic disc: 2700 pf \( \pm 10\%, \) 1000 VDCW; sim to RMC Type JF Discap.	R18 and R19	3R152
Polyester: 0.22 µf ±10%, 50 VDCW.	R20	3R152
Tantalum: 2.2 $\mu f$ $\pm 10\%$ , 20 VDCW; sim to Sprague Type 150D.	R21 and R22	3R771
Tantalum: 15 µf ±20%, 20 VDCW; sim to Sprague Type 150D.	R23	3R771
DIODES AND DESTRICTED	R25	3R771
DIODES AND RECTIFIERS Silicon, fast recovery, 225 mA, 50 PIV.	and R26	
	R27 and	3R771
Silicon, fast recovery, 225 mA, 50 PIV.	R28	
In REV F & earlier:	R29 R30*	3R771
Germanium, fast recovery, Reverse 20 volts, Fwd current 40 mA.	K3U*	3R771
Silicon, fast recovery, 225 mA, 50 PIV.		3R771
	R31	3R771
JACKS AND RECEPTACLES	R33	3R771
Contact, electrical: sim to Bead Chain L93-3.	R34	3R771
	R35	3R771
	R36 R38	3R771
Transformer, freq: 455 KHz; sim to TOKO PEFCN- 14733-CX12.	R39	3R771
Transformer, freq: 455 KHz; sim to TOKO PEFCN-14734-BNL2.	R40*	3R771
Choke. Includes:		3R771
Tuning slug.	R41	3R15
	R42	3R771
Silicon, NPN.	R43	19820
Silicon, NPN.	R44	19B2
In REV N & earlier:		
Silicon, NPN.	R45	3R771
Silicon, NPN.	R46	3R771
Silicon, NPN.	R48*	19A1
Silicon, NPN.		3R771
Silicon, NPN; sim to Type 2N2925.	R49	3R771
Silicon, NPN; sim to Type 2N5210.	R50	3R771
In REV G and earlier:	R51	3R77
Silicon, NPN.	R52	3R771
RESISTORS	R53*	3R771
Composition: 1K ohms ±10%, 1/2 w.		
Composition: 15K ohms ±5%, 1/2 w.		3R771
Composition: 82K ohms ±10%, 1/2 w.		
Composition: 4.7K ohms ±10%, 1/2 w.		3R77
Composition: 1K ohms ±10%, 1/2 w.	R54	3R77
Composition: 15K ohms ±5%, 1/2 w.	R55	3R77
Composition: 82K ohms ±10%, 1/2 w.	R56*	3R77
Composition: 4.7K ohms ±10%, 1/2 w.	R57	3 <b>R77</b> 1
Composition: 1K ohms ±10%, 1/2 w.	R58	3R77
Composition: 15K ohms ±5%, 1/2 w.		
-	L	L

SYMBOL	GE PART NO.	DESCRIPTION	SYMB
R11	3R77P823K	Composition: 82K ohms $\pm 10\%$ , 1/2 w.	R59
R12	3R77P472K	Composition: 4.7K ohms $\pm 10\%$ , 1/2 w.	R60
R13	3R77P272K	Composition: 2.7K ohms $\pm 10\%$ , 1/2 w.	and R61
R14	3R77P103J	Composition: 10K ohms ±5%, 1/2 w.	R64
R15	3R77P333J	Composition: 33K ohms ±5%, 1/2 w.	
R16	3R77P181K	Composition: 180 ohms $\pm 10\%$ , 1/2 w.	
R17	3R152P471J	Composition: 470 ohms ±5%, 1/4 w.	R66
R18 and R19	3R152P513J	Composition: 51K ohms ±5%, 1/4 w.	R77
R20	3R152P472J	Composition: 4.7K ohms ±5%, 1/4 w.	
R21 and R22	3R77P362J	Composition: 3.6K ohms ±5%, 1/2 w.	R79
R23	3R77P104K	Composition: 100K ohms ±10%, 1/2 w.	R8C
R24	3R152P102J	Composition: 1K ohms ±5%, 1/4 w.	
R25 and R26	3R77P103K	Composition: 10K ohms ±10%, 1/2 w.	
R27	3R77P753J	Composition: 75K ohms ±5%, 1/2 w.	R81
and R28			R82
R29	3R77P182J	Composition: 1.8K ohms ±5%, 1/2 w.	1
R30*	3R77P821J	Composition: 820 ohms ±5%, 1/2 w.	R86
		In REV C & earlier:	
	3R77P102J	Composition: 1K ohms ±5%, 1/2 w.	
R31	3R77P821J	Composition: 820 ohms ±5%, 1/2 w.	RTI
R33	3R77P912J	Composition: 9.1K ohms ±5%, 1/2 w.	RT2
R34	3R77P332K	Composition: 3.3K ohms ±10%, 1/2 w.	and RT3
R35	3R77P330K	Composition: 33 ohms ±10%, 1/2 w.	1
R36	3R77P681J	Composition: 680 ohms ±5%, 1/2 w.	т1
R38	3R77P752J	Composition: 7.5K ohms ±5%, 1/2 w.	
R39	3R77P820J	Composition: 82 ohms ±5%, 1/2 w.	
R40*	3R77P221J	Composition: 220 ohms ±5%, 1/2 w.	A350
		In REV H & earlier:	
	3R77P241J	Composition: 240 ohms ±5%, 1/2 w.	
R41	3R152P240J	Composition: 24 ohms ±5%, 1/4 w.	Cl
R42	3R77P200J	Composition: 20 ohms ±5%, 1/2 w.	C2
R43 R44	19B209358P101 19B209022P101	Variable, carbon film: approx 25 to 250 ohms ±10%, 0.2 w; sim to CTS Type X-201.  Wirewound: 0.27 ohms ±10%, 2 w; sim to IRC Type	C3
		вwн.	C5
R45	3R77P123J	Composition: 12K ohms ±5%, 1/2 w.	C6
R46	3R77P913J	Composition: 91K ohms ±5%, 1/2 w.	C7
R48*	19A116278P249	Metal film: 3.1K ohms $\pm 2\%$ , $1/2$ w.	C8
	1	In REV A & earlier:	С9
	3R77P302J	Composition: 3K ohms ±5%, 1/2 w.	Cl
R49	3R77P103J	Composition: 10K ohms ±5%, 1/2 w.	C1
R50	3R77P222J	Composition: 2.2K ohms ±5%, 1/2 w.	Cl
R51	3R77P103J	Composition: 10K ohms ±5%, 1/2 w.  Composition: 6.8K ohms ±5%, 1/2 w.	Cl
R52	3R77P682J	Composition: 22K ohms ±5%, 1/2 w.	C1
R53*	3R77P223J	In REV E & earlier:	C1
	3R77P303J	Composition: 30K ohms ±5%, 1/2 w.	Cl
	0	In REV B & earlier:	C1
	3R77P473J	Composition: 47K ohms ±5%, 1/2 w.	
R54	3R77P473J 3R77P822J	Composition: 8.2K ohms ±5%, 1/2 w.	C1
R55	3R77P8223	Composition: 10K ohms ±10%, 1/2 w.	Cl
R56*	3R77P103R 3R77P224J	Composition: 0.22 megohms ±5%, 1/2 w. Deleted by REV R.	C2
	I		1 .
R57	3R77P103K	Composition: 10K ohms ±10%, 1/2 w.	C2

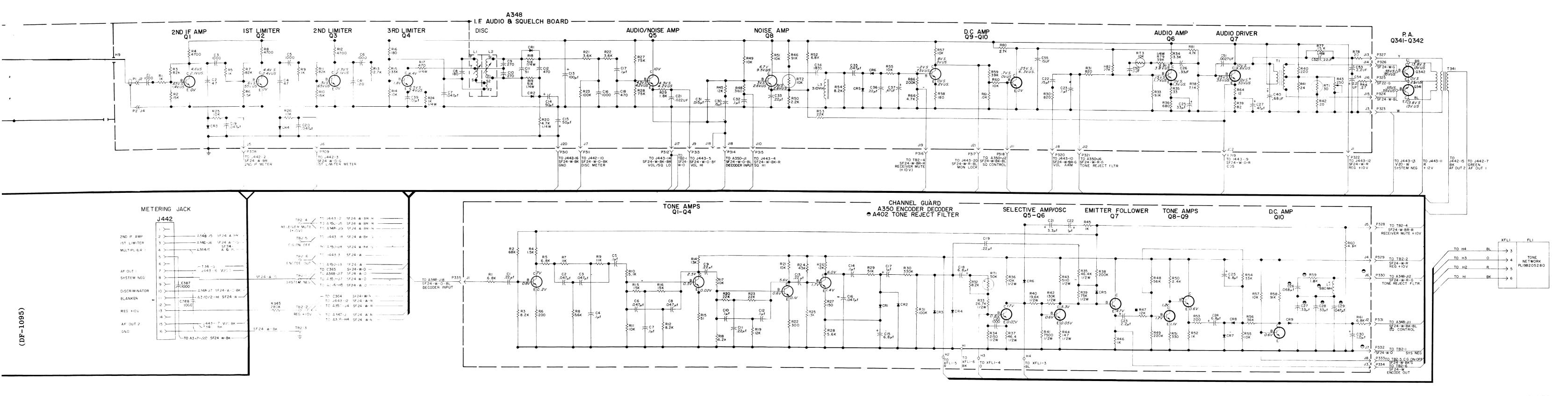
SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL
R59	3R77P393K	Composition 20% character 1/2 m	C22
R60 and	3R77P103K	Composition: 39K ohms ±10%, 1/2 w.  Composition: 10K ohms ±10%, 1/2 w.	C23
R61 R64*	3R77Pl20J	Composition: 12 ohms ±5%, 1/2 w.	C24
		In REV B & earlier:	C25
	3R77P180J	Composition: 18 ohms ±5%, 1/2 w.	C26
R66	3R77P472K	Composition: 4.7K ohms ±10%, 1/2 w.	C27
R77	3R152P153J	Composition: 15K ohms ±5%, 1/4 w.	and C28
R78*	3R77P20 <b>0</b> J	Composition: 20 ohms ±5%, 1/2 w.	C29*
	0000000	In REV C & earlier:	
220	3R77P100J	Composition: 10 ohms ±5%, 1/2 w.	
R79	3R152P393J	Composition: 39K ohms ±5%, 1/4 w.	C30
R80*	3R152P272J	Composition: 2.7K ohms ±5%, 1/4 w.  In REV L & earlier:	
	3R152P432J	Composition: 4.3K ohms ±5%, 1/4 w.	1
R81	3R152P472J	Composition: 4.5% ohms ±5%, 1/4 w.	CR1
R82	3R77P273J	Composition: 27K ohms ±5%, 1/2 w.	and CR2
R85*	3R152P102J	Composition: 1K ohms ±5%, 1/4 w. Added by REV K. Deleted by REV L.	CR3 and
R86*	3R77P204J	Composition: 200K ohms ±5%, 1/2 w. Added by REV R.	CR4 CR5
			CR6
			CR7
RT1	5490828P41	Thermistor: 30 ohms ±10%, color code black/white; sim to Carborundum Bl211J-4.	thru CR9
RT2 and RT3	5490828P9	Thermistor: 10K ohms ±10%, color code yellow; sim to Carborundum 551J-8.	FL1
			FLI
Tl	19A116040P1	Audio freq: 300-4000 Hz, Pri. Condition A: 325 ohms ±5% imp, Condition B: 315 ohms ±5% imp, Sec: 480 ohms imp.	
A350		ENCODER/DECODER 4EK16A10 19C311797G1	
		CAPACITORS	
Cl	19A116080P9	Polyester: 0.22 µf ±20%, 50 VDCW.	
C2 and C3	19A116080P205	Polyester: 0.047 µf ±5%, 50 VDCW.	
C4	19A116080P207	Polyester: 0.1 µf ±5%, 50 VDCW.	1
C5	19A116080P7	Polyester: 0.1 µf ±20%, 50 VDCW.	
C6	19A116080P205	Polyester: 0.047 µf ±5%, 50 VDCW.	1
C7	19A116080P207	Polyester: 0.1 µf ±5%, 50 VDCW.	
C8	19A116080P205	Polyester: 0.047 µf ±5%, 50 VDCW.	
C9	19A116080P9	Polyester: 0.22 µf ±20%, 50 VDCW.	
C10	19A116080P207	Polyester: 0.1 µf ±5%, 50 VDCW.	Jl thru
C11	19A116080P109	Polyester: 0.22 µf ±10%, 50 VDCW.	J8
C12	19A116080P207	Polyester: 0.1 µf ±5%, 50 VDCW.	
C13	19A116080P9	Polyester: 0.22 µf ±20%, 50 VDCW.	Ll
C14	19A116080P7	Polyester: 0.1 µf ±20%, 50 VDCW.	
C15	5496267P1	Tantalum: 6.8 µf ±20%, 6 VDCW; sim to Sprague Type 150D.	Q1
C16	19A116080P5	Polyester: 0.047 μf ±20%, 50 VDCW.	Q2
C17	5496267P417	Tantalum: 1.0 µf ±5%, 35 VDCW; sim to Sprague Type 150D.	Q3 and Q4
C18	5496267P1	Tantalum: 6.8 µf ±20%, 6 VDCW; sim to Sprague Type 150D.	Q5 thru
C19	19A116080P109	Polyester: 0.047 µf ±10%, 50 VDCW.	Q8
C20	5494481P111	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.	Q9 and Q10
	5496267P9	Tantalum: 3.3 µf ±20%, 15 VDCW; sim to	1

SYMBOL	GE PART NO.	DESCRIPTION	SY	MBOL	GE PART NO.	DESCRIPTION
C22	5496267P17	Tantalum: 1.0 \( \mu f \pm 20\%, 35  \text{VDCW}; \text{ sim to Sprague} \)				RESISTORS
202	5400007D12	Type 150D.	F	R1	3R77P682K	Composition: 6.8K ohms ±10%, 1/2 w.
C23	5496267P13	Tantalum: 2.2 $\mu f$ $\pm 20\%$ , 20 VDCW; sim to Sprague Type 150D.	R	R2	3R77P683J	Composition: $68K$ ohms $\pm 5\%$ , $1/2$ w.
C24	5496267Pl	Tantalum: 6.8 $\mu$ f $\pm 20\%$ , 6 VDCW; sim to Sprague Type 150D.	F	R3	3R77P822J	Composition: 8.2K ohms ±5%, 1/2 w.
C25	5496267P18	Tantalum: 6.8 µf ±20%, 35 VDCW; sim to Sprague	F	R4	3R77P152J	Composition: 1.5K ohms ±5%, 1/2 w.
		Type 150D.	R	₹5	3R77P682K	Composition: 6.8K ohms $\pm 10\%$ , 1/2 w.
C26	19A116080P206	Polyester: 0.068 μf ±5%, 50 VDCW.		R6	3R77P201J	Composition: 200 ohms $\pm 5\%$ , $1/2$ w.
C27 and	19A116080P210	Polyester: 0.33 µf ±5%, 50 VDCW.	}	R7	19A116278P305	Metal film: $11$ K ohms $\pm 2\%$ , $1/2$ w.
C28	1041160000000	Dalumatana 0 045	R	88	3R77P562J	Composition: 5.6K ohms ±5%, 1/2 w.
C29*	19A116080P205	Polyester: 0.047 µf ±5%, 50 VDCW.			201500C00 v	In REV A & earlier:
	19B209243P107	In REV B & earlier:  Polyester: 0.1 µf ±10%, 50 VDCW.	ΙΙ.	19	3R152P622J 19A116278P305	Composition: 6.2K ohms ±5%, 1/4 w.
C30	5496267P17	Tantalum: 1.0 µf ±20%, 35 VDCW; sim to Sprague	1 1	210	3R77P512J	Metal film: llK ohms ±2%, 1/2 w.  Composition: 5.1K ohms ±5%, 1/2 w.
230	0100201111	Type 150D.		211	3R77P103J	Composition: 10K ohms ±5%, 1/2 w.
		DIODES AND RECTIFIERS		212	3R77P822J	Composition: 8.2K ohms ±5%, 1/2 w.
CR1	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV.		213	3R77P153J	Composition: 15K ohms ±5%, 1/2 w.
and CR2		, , ,	1 1	R14	3R77P133J	Composition: 13K ohms ±5%, 1/2 w.
CR3	5494922P1	Silicon; sim to Type lN456.		215	3R77P510J	Composition: 51 ohms ±5%, 1/2 w.
and CR4			R	116	3R77P153J	Composition: 15K ohms ±5%, 1/2 w.
CR5	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV.	R	217	3R77P103J	Composition: 10K ohms ±5%, 1/2 w.
CR6	4036887P3	Silicon, Zener: 500 mW, 3.8 v. nominal.	R	R18	3R77P622J	Composition: 6.2K ohms ±5%, 1/2 w.
CR7	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV.	R	119	3R77P123J	Composition: 12K ohms ±5%, 1/2 w.
thru CR9			R	R20	3R77P223J	Composition: 22K ohms ±5%, 1/2 w.
		PILTERS	R	R21	3R77P103J	Composition: 10K ohms ±5%, 1/2 w.
FLl		TONE FREQUENCY NETWORK	R	R22	3R77P301J	Composition: 300 ohms ±5%, 1/2 w.
FLI		19B205280	R	23	3R77P223J	Composition: 22K ohms ±5%, 1/2 w.
	19B205280G1 19B205280G2	71.9 Hz 77.0 Hz	R	R24	3R77P433J	Composition: 43K ohms ±5%, 1/2 w.
	19B205280G3 19B205280G4	82.5 Hz 88.5 Hz	R	R25	3R77P133J	Composition: 13K ohms ±5%, 1/2 w.
	19B205280G5 19B205280G6	94.8 Hz 100.0 Hz	R	R26	3R77P123J	Composition: 12K ohms ±5%, 1/2 w.
	19B205280G7 19B205280G8	103.5 Hz 107.2 Hz	R	R27	3R77P151J	Composition: 150 ohms $\pm 5\%$ , 1/2 w.
	19B205280G9 19B205280G10	110.9 Hz 114.8 Hz	R	128	3R77P562J	Composition: 5.6K ohms ±5%, 1/2 w.
	19B205280G11 19B205280G12	118.8 Hz 123.0 Hz	R	R29	3R77P513J	Composition: 51K ohms ±5%, 1/2 w.
	19B205280G13 19B205280G14	127.3 Hz 131.8 Hz	R	130	3R77P334J	Composition: 330K ohms ±5%, 1/2 w.
	19B205280G15 19B205280G16	136.5 Hz 141.3 Hz	R	31	3R77P104J	Composition: 100K ohms ±5%, 1/2 w.
	19B205280G17 19B205280G18	146.2 Hz 151.4 Hz	11	32	3R77P822J	Composition: 8.2K ohms ±5%, 1/2 w.
	19B205280G19 19B205280G20	156.7 Hz 162.2 Hz	I I	33	19A116278P333	Metal film: 26.7K ohms ±2%, 1/2 w.
	19B205280G21 19B205280G22 19B205280G23	167.9 Hz 173.8 Hz 179.9 Hz	11	34	19A116278P233	Metal film: 2.15K ohms ±2%, 1/2 w.
	19B205280G25 19B205280G24 19B205280G25	186.2 Hz 192.8 Hz	1 1	35	19A116278P365	Metal film: 46.4K ohms $\pm 2\%$ , $1/2$ w.  Metal film: 10K ohms $\pm 2\%$ , $1/2$ w.
	19B205280G26	203.5 Hz	1 1	R36	19A116278P301 19A116278P65	Metal film: 46.4 ohms ±2%, 1/2 w.
			1 1	R37 R38	3R77P204J	Composition: 200K ohms ±5%, 1/2 w.
Jl	4033513P4	Contact, electrical; sim to Bead Chain L93-3.	1 1	R39	19A116278P385	Metal film: 75K ohms ±2%, 1/2 w.
thru J8			1 1	R40	19A116278P329	Metal film: 19K ohms ±2%, 1/2 w.
			1 1	R41	19A116278P285	Metal film: 7.5K ohms $\pm 2\%$ , $1/2$ w.
Ll	19A115690P1	Coil, RF: 880 mh $\pm 5\%$ , sim to Artted AC5672.	11	R42	19A116278P412	Metal film: 130K ohms $\pm 2\%$ , $1/2$ w.
		TRANSISTORS		R43	19A116278P269	Metal film: 5.1K ohms $\pm 2\%$ , $1/2$ w.
	10111510051		,	R44	19A116278P117	Metal film: 147 ohms $\pm 2\%$ , 1/2 w.
Q1	19A115123P1	Silicon, NPN.		R45	3R77P102J	Composition: 1K ohms ±5%, 1/2 w.
Q2 Q3	19A115362P1 19A115123P1	Silicon, NPN; sim to Type 2N2925. Silicon, NPN.		and R46		
and Q4						$rac{ ext{NOTE}}{ ext{The value of Resistor}}$ must be obtained from
Q5 thru Q8	19A115362P1	Silicon, NPN; sim to Type 2N2925.	.	R47A	3R77P822J	the component, then find corresponding value in parts list for the correct part number.  Composition: 8.2K ohms ±5%, 1/2 w.
Q9 and Q10	19A115123P1	Silicon, NPN.			3	
						(Cont'd on Page 16)



## SCHEMATIC DIAGRAM

25—50 MHz MASTR RECEIVER MODELS 4ER39C68-85



### SCHEMATIC DIAGRAM

25—50 MHz MASTR RECEIVER MODELS 4ER39C68-85

Issue 8

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4 (Cor	t'd from Page 13) (LE	14134)								- <b>F</b>					٦	<del></del>			<del></del>				
	MBOL GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION
			C45	5490008P35	Silver mica: 220 pf ±5%, 500 VDCW.	A364,		MULTIPLIER SELECTIVITY ASSEMBLY				C30	19A116080P1	Polyester: .01 μf ±20%, 50 VDCW.	R14	3R152P203J	Composition: 20K ohms ±5%, 1/4 w.	C37	5496218P48	Ceramic disc: 24 pf ±5%, 500 VDCW, temp coef			
1	R47B 3R77P912J R47C 3R77P103J	Composition: 9.1K ohms ±5%, 1/2 w.  Composition: 10K ohms ±5%, 1/2 w.	C46	1	Ceramic disc: 100 pf ±5%, 500 VDCW, temp coef	A365 and		A364 19B205326G6 A365 19B205326G7	Q1*	19A116960P1	N Type, field effect; sim to Type 2N4416.	C39	19A116080P1	Polyester: .01 µf ±20%, 50 VDCW.	R15	3R152P332K	Composition: 3.3K ohms ±10%, 1/4 w.			О РРМ.	R3	3R152P392J	Composition: 3.9K ohms ±5%, 1/4 w.
- 1	R47D 3R77P113J	Composition: 11K ohms ±5%, 1/2 w.			-330 РРМ.	A406		A406 19B205326G8	]		In G4 of REV P & earlier:	C40	5491601P23	Phenolic: 1.5 pf ±10%, 500 VDCW.	R16	3R152P102K	Composition: 1K ohms ±10%, 1/4 w.				R4*	3R152P562K	Composition: 5.6K ohms $\pm 10\%$ , 1/4 w. Deleted by REV A.
	R47E 3R77P123J	Composition: 12K ohms ±5%, 1/2 w.			DIODES AND RECTIFIERS					19A115953P1	In G5 & G6 of REV M & earlier:  N Channel, field effect.	C41	5491601P22	Phenolic: 1.2 pf ±10%, 500 VDCW.	R17	3R152P183K	Composition: 18K ohms ±10%, 1/4 w.	L8	19A121395P1	Coil.	R5*	3R152P202J	Composition: 2K ohms ±5%, 1/4 w. Deleted by REV A.
ļ	R47F 3R77P133J	Composition: 13K ohms ±5%, 1/2 w.	CR1	19A115603P1	Silicon.	C1	5496218P252	Ceramic disc: 36 pf ±5%, 500 VDCW, temp coef	1	19811383371	R Chamber, Freid effect.	C42*	7491827P102	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to Sprague Type 19C.	R18	3R152P202J	Composition: 2K ohms ±5%, 1/4 w.			RESISTORS	R6	3R152P562K	Composition: 5.6K ohms ±10%, 1/4 w.
	R47G 3R77P153J	Composition: 15K ohms ±5%, 1/2 w.	thru CR4			C2		-50 РРМ.			RESISTORS			In REV E & earlier:	R19 and	3R152P102K	Composition: 1K ohms ±10%, 1/4 w.	R24	3R152P752J	Composition: 7.5K ohms ±5%, 1/4 w.	Rll	3R152P101K	Composition: 100 ohms $\pm 10\%$ , $1/4$ w.
	R47H 3R77P752J	Composition: 7.5K ohms ±5%, 1/2 w.			JACKS AND RECEPTACLES	C3	5496218P251	Ceramic disc: 33 pf ±5%, 500 VDCW, temp coef -80 PPM.	R1	3R152P513J	Composition: 51K ohms ±5%, 1/4 w.		5494481P116	Ceramic disc: 3000 pf ±10%, 1000 VDCW; sim to	R20				5491798P4	Tuning slug. (Used in T7 and T8).	and R12		
	R48 3R77P563J	Composition: 56K ohms ±5%, 1/2 w.	Jl thru	4033513P4	Contact, electrical: sim to Bead Chain L93-3.	C4	5496218P248	Ceramic disc: 24 pf ±5%, 500 VDCW, temp coef	R2 R3	3R152P332K 3R152P101K	Composition: 3.3K ohms ±10%, 1/4 w.	C43	7491827P102	RMC Type JF Discap.  Ceramic disc: .01 \( \mu f + 80\% - 30\% \), 50 VDCW; sim to	R21		Composition: 2K ohms ±5%, 1/4 w.		5491798P5	Tuning slug. (Used in T9).	R13*	3R152P202J	Composition: 2K ohms ±5%, 1/4 w. Added by
- 1	R49 3R77P224J	Composition: 220K ohms ±5%, 1/2 w.	J6		TURNISTORS	and C5	1	-80 PPM.	and	3R152P101K	Composition: 100 ohms ±10%, 1/4 w.	045	14310277102	Sprague Type 19C.	R22*	3R152P102K	Composition: 1K ohms ±10%, 1/4 w. Deleted by REV C. Added by REV D.	T10		COIL ASSEMBLY	R14*	3R152P102J	Composition: 1K ohms ±5%, 1/4 w. Added by
1	R50 3R77P242J	Composition: 2.4K ohms ±5%, 1/2 w.	L2	7488079P16	INDUCTORS	C6	5496218P247	Ceramic disc: 22 pf ±5%, 500 VDCW, temp coef	A.4	1		C44	19A116080P7	Polyester: 0.1 µf ±20%, 50 VDCW.	R26	3R152P101K	Composition: 100 ohms ±10%, 1/4 w.	thru		T10 19B204697G1 T11 19B204697G2	"		REV A.
l l	R51 3R77P331J	Composition: 330 ohms ±5%, 1/2 w.	and	7488079916	DC res; sim to Jeffers 4421-7K.	C7	5493392P107	Ceramic, stand off: 1000 pf +100% -0%, 500 VDCW;	A370 thru		NOISE BLANKER A370 19C3O3540G1			DIODES AND RECTIFIERS				***	1	T12 19B204697G3	A402		TONE REJECT FILTER
	R52 3R77P102J	Composition: 1K ohms ±5%, 1/2 w.  Composition: 200 ohms ±5%, 1/2 w.	1 23		TRANSISTORS	and C8	0.0000000000000000000000000000000000000	sim to Allen-Bradley Type SS5D.	A372		A371 19C303540G2 A372 19C303540G3	CR1	19A115775P1	Silicon, fast recovery, 225 mA, 50 PIV.	T1	1	COIL ASSEMBLY						19C311797G2
	R53 3R77P201J R54 3R77P333J	Composition: 200 onms 15%, 1/2 w.	Q1	19A115330Pl	Silicon, NPN.	C9	5491601P123	Phenolic: 1.5 pf ±5%, 500 VDCW.		}		CR2*	4038056P1	Germanium, fast recovery, Reverse 20 volts, Fwd current 40 mA. Deleted by REV C. Added by REV D.	thru T3		T1 19B204694G1 T2 19B204694G2	C4	5496218P63	Ceramic disc: 100 pf ±5%, 500 VDCW, temp coef			CAPACITORS
	R55 3R77P103J	Composition: 10K ohms ±5%, 1/2 w.	and Q2			C10	5491601P117	Phenolic: 0.68 pf ±5%, 500 VDCW.	C5	5491601P28		CR3*	19A115775P1	Silicon, fast recovery, 225 mA, 50 PIV.			T3 19B204694G3	0154	19B209170P2	0 PPM. Ceramic disc: .01 μf +80% -30%, 50 VDCW; sim to	C26	19A116080P206	Polyester: 0.068 μf ±5%, 50 VDCW.
	R56 3R77P363J	Composition: 36K ohms ±5%, 1/2 w.	İ		RESISTORS	C11	5491601P118	Phenolic: 0.75 pf ±5%, 500 VDCW.	C6*	7491827P102	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to	05	10.11011011	In REV C:		1		and	198209170P2	Sprague Type 19C. Deleted by REV E.	C27	19A116080P210	Polyester: 0.33 µf ±5%, 50 VDCW.
	R57 3R77P103K	Composition: 10K ohms ±10%, 1/2 w.	R1	3R152P562J	Composition: 5.6K ohms ±5%, 1/4 w.	C13	5491601P137	Phenolic: 0.91 pf ±5%, 500 VDCW.		14310277102	Sprague Type 19C. Added by REV E.		19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV.	C1	5496218P62	Ceramic disc: 91 pf ±5%, 500 VDCW, temp coef	C34	5496218P58	Ceramic disc: 62 pf ±5%, 500 VDCW, temp coef	C28		
	R58 3R77P913J	Composition: 91K ohms ±5%, 1/2 w.	R4			C14	5491601P114	Phenolic: 0.51 pf ±5%, 500 VDCW.	C7*	7491827P102	Ceramic disc: .01 \( \mu f + 80\% - 30\% \), 50 VDCW; sim to Sprague Type 19C.			In REV B & earlier:	C6*	19B209170P2	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to	001	0.00210.00	O PPM.	C29*	19A116080P205	Polyester: 0.047 µf ±5%, 50 VDCW.
	R59* 3R77P182J	Composition: 1.8K ohms ±5%, 1/2 w.	R5 thru	3R152P104K	Composition: 0.1 megohm ±10%, 1/4 w.	C15	5491601P115	Phenolic: 0.56 pf ±5%, 500 VDCW.	C8*		In REV D & earlier:		4038056P1	Germanium, fast recovery, Reverse 20 volts, Fwd			Sprague Type 19C. Deleted by REV E.	C38	5496218P49	Ceramic disc: 27 pf ±5%, 500 VDCW, temp coef 0 PPM.			Earlier than REV A:
		In REV C & earlier:	R8			C34 and	5491601P127	Phenolic: 2.4 pf ±5%, 500 VDCW.		7491827P2	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to	CR4	4038056Pl	current 40 mA.  Germanium, fast recovery, Reverse 20 volts, Fwd	C31	5496218P256	Ceramic disc: 51 pf ±5%, 500 VDCW, temp coef -80 PPM.		1			19B209243P107	Polyester: 0.1 µf ±10%, 50 VDCW.
	3R152P432J	Composition: 4.3K ohms ±5%, 1/4 w.	R9	3R152P153J	Composition: 15K ohms ±5%, 1/4 w.	C35			G0+	7491827P106	Sprague Type 19C.  Ceramic disc: .025 μf +80% -20%, 50 VDCW;	CR4	403803071	current 40 mA.	C35	5496218P49	Ceramic disc: 27 pf ±5%, 500 VDCW, temp coef		19A121396P1	Codd			JACKS AND RECEPTACLES
	R60 3R77P432J	Composition: 4.3K ohms ±5%, 1/2 w.	R10	1	Composition: 100 ohms ±10%, 1/4 w.	C36	5491601P126	Phenolic: 2.2 pf ±5%, 500 VDCW.	(3*	74910277100	sim to Sprague Type 29C.	CR5	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV.			O PPM.	1	19A121396P1 19A115046P263	Coil	J6 and	4033513P4	Contact, electrical; sim to Bead Chain L93-3.
1	R61 3R77P682K	Composition: 6.8K ohms $\pm 10\%$ , $1/4$ w.	Rll and	3R152P102J	Composition: 1K ohms ±5%, 1/4 w.			DIODES AND RECTIFIERS			In REV D & earlier:	CR6*	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV.				210	15/11/10/10/205		J7		
			R12	3R152P103J	Composition: 10K ohms ±5%, 1/4 w.	CR1	4038056P1	Germanium, fast recovery, Reverse 20 volts, Fwd current 40 mA.		7491827P3	Ceramic disc: .025 $\mu$ f +80% -20%, 50 VDCW; sim to Sprague Type 29C.	CR7*		In REV B & earlier:	L6	19A121393P1	Coil.	1		RESISTORS			
ĺ	RT1 5490828P22	Thermistor: 50K ohms ±10%, color code yellow; sim to Carborundum Type 763H-J4.	R15	3R152P101K	Composition: 100 ohms ±10%, 1/4 w.				C10*	7491827P102	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to		4038056P1	Germanium, fast recovery, Reverse 20 volts, Fwd current 40 mA.	Lll		Coil.	R25	3R152P822K	Composition: 8.2K ohms ±10%, 1/4 w.	L1	19A115690P1	Coil, RF: 880 mh ±5%, sim to Artted AC5672.
		Sim to Carborandam Type Youn 021	R19	3R152P360J	Composition: 36 ohms ±5%, 1/4 w.				and Cll*		Sprague Type 19C. Added by REV E.		1	current 40 mA.		5491798P4 5491798P5	Tuning slug. (Used in T1 and T2).	1	5491798P5 5491798P4	Tuning slug. (Used in T12).  Tuning slug. (Used in T10 and T11).			RESISTORS
l			R21	3R152P750J	Composition: 75 ohms ±5%, 1/4 w.	L1		(Part of T1 and T4).  (Part of T2 and T5).	C12*	7491827P102	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to Sprague Type 19C.				11	549179825	Tuning slug. (Used in T3).		5491798P4	luning sing. (used in 110 and 111).	R59*	3R152P182J	Composition: 1.8K ohms ±5%, 1/4 w.
	XFL1 19A121920G3	Reed, mica-filled phen: 7 pins rated at 1 amp at 500 VRMS with 4-1/2 inches of cable.				1.3		(Part of T3 and T6).	C13*		In REV D & earlier:	Ll thru	7488079P17	Choke, RF: 12.0 µh ±10%, 1.00 ohms DC res max; sim to Jeffers 4421-8K.	T4 thru		COIL ASSEMBLY T4 19B204695G1	A376		LEVEL SHUT-OFF SWITCH 19C3O3985G1			In REV A & earlier:
		FIRST OSCILLATOR ASSEMBLY	RT1	19B209284P5	Disc: 43 ohms res nominal at 25°C, color code			(1220 02 10 222 10))		7491827P2	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to	L5			Т6		T5 19B204695G2 T6 19B204695G3		Ì			3R152P432J	Composition: 4.3K ohms ±5%, 1/4 w.
th	52 ru	A352 19B204419G13 A353 19B204419G16	thru RT4	10000000	green.						Sprague Type 19C.		10411504001								A404		CRYSTAL FILTER 19B2O4616G10
AS	"	A354 19B204419G14 A355 19B204419G17				Rl	3R152P473K	Composition: 47K ohms ±10%, 1/4 w.	C14*	7491827P106	Ceramic disc: .025 µf +80% -20%, 50 VDCW; sim to Sprague Type 29C.	Q1 thru	19A115342P1	Silicon, NPN.		5.4000,000		C1	5496219P237	Ceramic disc: 6 pf ±0.25 pf, 500 VDCW, temp coef -80 PPM.			198204010010
		A356 19B204419G15 A357 19B204419G18	Т3		COIL ASSEMBLY T3 19B205416G1						In REV D & earlier:	Q4*	19All5779Pl	Silicon, PNP; sim to Type 2N3251.	C2	5496218P61	O PPM.	C2	19A116080P1	Polyester: .01 µf ±20%, 50 VDCW.			
			and T4		T4 19B205416G2	Tl	19B205325G2	Coil, includes:		7491827P3	Ceramic disc: .025 \( \text{\psi} f +80\% -20\%, 50 \) VDCW; sim to Sprague Type 29C.	'		In REV D & earlier:	C10*	19B209170P2	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to Sprague Type 19C. Deleted by REV E.	СЗ	5494481P111	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.	FL5	19B206692G1	Bandpass.
i							5491798P4	Tuning slug.	C15*	7491827P102	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to		19A115768P1	Silicon, PNP.	C32	5496218P55	Ceramic disc: 47 pf ±5%, 500 VDCW, temp coef	C4	7491827P2	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to	-		RESISTORS
	Cl 5494481P112 thru	RMC Type JF Discap.	C34	5496218P253	Ceramic disc: 39 pf ±5%, 500 VDCW, temp coef	T2 and	19B205325G1	Coil, includes:	and C16*		Sprague Type 19C. Added by REV E.	Q5	19A115706P1	Silicon, PNP.			0 PPM.			Sprague Type 19C.	R8	3R152P103K	Composition: 10K ohms ±10%, 1/4 w.
	C5 5496219P751	Ceramic disc: 33 pf ±5%, 500 VDCW, temp coef			-80 PPM.	Т3	5491798P4	Tuning slug.	C17*	5494481P112	Ceramic disc: 1000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap. Deleted by REV C. Added by	Q7			C36	5496218P46	Ceramic disc: 20 pf ±5%, 500 VDCW, temp coef 0 PPM.	C5 and	19A116080P5	Polyester: .047 μf ±20%, 50 VDCW.	R14*	3R152P752K	Composition: 7.5K ohms $\pm 10\%$ , $1/4$ w. Deleted in 19E500873G4 by REV K. Deleted in 19E500873G5, G6
İ	thru C8	-750 PPM.	C35	5 5496218P249	Ceramic disc: 27 pf ±5%, 500 VDCW, temp coef -80 PPM.	T4	19B205325G2	Coil, includes:			REV D.			RESISTORS			INDUCTORS	C6	7774750P11	Ceramic disc: .005 µf +100% -0%, 500 VDCW.			by REV J.
	C9 5491271P106	Variable, subminiature: approx 2.1-12.7 pf,	Ì			1 75	5491798P4 19B205325G1	Tuning slub. Coil, includes:	C18	5496219P55	Ceramic disc: 47 pf ±5%, 500 VDCW, temp coef 0 PPM.	Rl	3R152P682K	Composition: 6.8K ohms ±10%, 1/4 w.	1.7	19A121394P1	Coil.	C8	19A116080P3	Polyester: .022 µf ±20%, 50 VDCW.	A406	İ	(See A364 and A365)
	thru C12	750 v peak; sim to EF Johnson 189.	1.4	19A121464P2	Coil.	and T6	5491798P4	Tuning slug.	C19	5494481P112	Ceramic disc: 1000 pf ±10%, 1000 VDCW; sim to	R2	3R152P202J	Composition: 2K ohms ±5%, 1/4 w.									RF AMPLIFIER
	C13 5496219P40 thru	Ceramic disc: 9 pf ±0.25 pf, 500 VDCW, temp coef 0 PPM.		5491798P5	Tuning slug.						RMC Type JF Discap.	R3 R4	3R152P511J	Composition: 510 ohms ±5%, 1/4 w.  Composition: 390 ohms ±10%, 1/4 w.						DIODES AND RECTIFIERS	A407*		19B204770G2 (Added to 19E500873G4 by REV G)
	C16	1				A369		FIRST MIXER ASSEMBLY 19B216867G2	C20 C21*	1	Polyester: 0.1 \( \psi \) f \( \pm 20\% \), 50 VDCW.  Ceramic disc: 1000 pf \( \pm 10\% \), 1000 VDCW; sim to	R5	3R152P391K 3R152P682K	Composition: 6.8K ohms ±10%, 1/4 w.	R23	3R152P752J 5491798P4	Composition: 7.5K ohms ±5%, 1/4 w. Tuning slug. (Used in T4 and T5).	CR1*	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV. In 19E500873G4 of REV G & earlier:			(
	C17 19C300685P93	Ceramic disc: 5 pf ±0.1 pf, 500 VDCW, temp coef 0 PPM.			Refer to Mecanical Parts (RC1692).				(21*	54544617112	RMC Type JF Discap. Deleted by REV C. Added	R6	3R152P202J	Composition: 2K ohms ±5%, 1/4 w.		5491798P5	Tuning slug. (Used in T6).			In 19E500873G5, G6 of REV F & earlier:			
	C20	Ceramic disc: 220 pf ±5%, 500 VDCW, temp coef	thru		meter to metalical Parts (Metoss).		5496218P258	Ceramic disc: 62 pf ±5%, 500 VDCW, temp	C22	5494481P112	Ceramic disc: 1000 pf ±10%, 1000 VDCW; sim to	R7	3R152P511J	Composition: 510 ohms ±5%, 1/4 w.		013112613	1411216 42261 (4333 211 23)		4038056P1	Germanium, fast recovery, Reverse 20 volts, Fwd current 40 mA.	C2	7774750P11	Ceramic disc: .005 µf +100% -0%, 500 VDCW.
İ	C21 5496219P771	-750 PPM.	^114				01002101200	coef -80 PPM.			RMC Type JF Discap.	R8	3R152P391K	Composition: 390 ohms ±10%, 1/4 w.	T7 thru		COIL ASSEMBLY T7 19B204696G1				C3*	5494481P11	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap. Added by REV M.
	C22 5496219P773	Ceramic disc: 270 pf ±5%, 500 VDCW, temp coef			NOTE: When reordering give GE Part No. and	C2 and	5494481P127	Ceramic disc: 2700 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.	C23	5496219P51	Ceramic disc: 33 pf ±5%, 500 VDCW, temp coef 0 PPM.	R9	3R152P432J	Composition: 4.3K ohms ±5%, 1/4 w.	Т9		T8 19B204696G2 T9 19B204696G3						DIODES AND RECTIFIERS
	C23 5494481P114	Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to			specify exact freq needed.	C3		0 marks discuss 1000 at 1000 1000 mpows =1= 1	C24	19A116080P5	Polyester: .047 µf ±20%, 50 VDCW.	R10	3R152P101K	Composition: 100 ohms ±10%, 1/4 w.				L1	19B209456P127	Coil, RF: 39 µh ±10%, 1.9 ohms DC res max; sim to Arco-Speer 155-390K.	CR1*	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV. Deleted
		RMC Type JF Discap.			25-42 MHz crystal freq = $(\frac{OF + 5.30 \text{ MHz}}{3})$	C4	5494481P111	Ceramic disc: 1000 pf $\pm 20\%$ , 1000 VDCW; sim to RMC Type JF Discap.	C25	1	Polyester: 0.1 µf ±20%, 50 VDCW.	R11	3R152P562K	Composition: 5.6K ohms ±10%, 1/4 w.		5496218P62	Ceramic disc: 91 pf ±5%, 500 VDCW, temp coef	L2	7488079P48	Choke, RF: 27 $\mu$ h $\pm 10\%$ , 1.40 ohms DC res max; sim to Jeffers 4422-9K.	CK1*	15/11323091	by REV M.
	C26 5494481P112 thru	Ceramic disc: 1000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.			42-50 MHz crystal freq = $(\frac{OF -5.30 \text{ MHz}}{3})$	C5	5494481P11	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.	C26	5494481P112	Ceramic disc: 1000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.	R12*	3R152P822J	Composition: 8.2K ohms ±5%, 1/4 w.		3430210702	0 PPM.						In 19E500873G4 of REV G & earlier: In 19E500873G5, G6 of REV F & earlier:
	C28	Ceramic disc: 1000 pf ±10%, 1000 VDCW; sim to				Ce	19A116114P2020		C27	4029003P8	Silver mica: 1000 pf ±5%, 500 VDCW; sim to			In REV D & earlier:	C11*	19B209170P2	Ceramic disc: .01 µf +80% -30%, 50 VDCW; sim to Sprague Type 19C. Deleted by REV E.		1			4038056P1	Germanium, fast recovery, Reverse 20 volts, Fwd
	C31 5494481P112	RMC Type JF Discap.	Y1 thru	19B206576Pl	Quartz: freq range 10086.666 to 12766.366 KHz, temp range -30°C to +85°C. (25-33 MHz).	"		-80 PPM.			Electro Motive Type DM-20.		3R152P822K	Composition: 8.2K ohms ±10%, 1/4 w.	С33	5496218P256	Ceramic disc: 51 pf ±5%, 500 VDCW, temp coef	Q1*	19A115245P1	Silicon, NPN. Deleted by REV A.			current 40 mA.
			Y4						C28	ı	Polyester: 0.1 µf ±20%, 50 VDCW.	R13*	3R152P104J	Composition: 0.1 megohm ±5%, 1/4 w. In REV D & earlier:			-80 PPM.	Q2	19A115123P1	Silicon, NPN.			
			Y1 thru	19B206576P2	Quartz: freq range 12766.667 to 15766.666 KHz, temp range -30°C to +85°C. (33-42 MHz).	L1	19B216880G1	Coil.	C29*	7491827P102	Ceramic disc: .01 $\mu$ f +80% -30%, 50 VDCW; sim to Sprague Type 19C.		3R152P104K	Composition: 0.1 megohms ±10%, 1/4 w.				Q3*	19A115440P1	Silicon, NPN. Added by REV A.	Q1	19A115342P1	Silicon, NPN.
			Y4	10D000EECD0	Quartz: freq range 12233.333 to 16233.333 KHz,						In REV E & earlier:									RESISTORS			
			Y1 thru	19B206576P3	Quartz: freq range 12233.333 to 10233.333 km2, temp range -30°C to +85°C. (42-54 MHz).					5494481P114	Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.					1		R1	3R152P102K	Composition: 1K ohms ±10%, 1/4 w.			(Cont'd on Page 17)
		1	Y4	1		1	1					1	1		11	1	1	R2	3R152P123K	Composition: 12K ohms $\pm 10\%$ , 1/4 w.	1	t	(Cont a on Page 11)

(Cont'd from	n Page	16)	(LBI41	34)
SYMBOL	GE	PART	NO.	

		RESISTORS	١
R1*	3R152P202J	Composition: 2K ohms ±5%, 1/4 w.	1
	5K10212030	In REV L & earlier:	1
	3R152P510J	Composition: 51 ohms ±5%, 1/4 w.	
	okiobi oi o	22,7, 2,7 2 3.	1
		TERMINAL BOARDS	١
TB1	7487424P19	Miniature, phen: 3 terminals.	-
		CHASSIS AND RF ASSEMBLY 19E500873G4 19E500873G5 19E500873G6	
C358 thru C365	5493392P7	Ceramic feed-thru: 1000 pf +100%-0%, 500 VDCW; sim to Allen-Bradley Type FA5C.	
C367 and C368	5493392P7	Ceramic, feed-thru: 1000 pf +100%-0%, 500 VDCW; sim to Allen Bradley Type FASC.	
C372	5491601P107	Phenolic: 0.27 pf ±5%, 500 VDCW.	-
C373	5491601P114	Phenolic: 0.51 pf ±5%, 500 VDCW.	
C378	5491601P110	Phenolic: 0.36 pf ±5%, 500 VDCW.	
C379	5491601P114	Phenolic: 0.51 pf ±5%, 500 VDCW.	
C380	5491601P115	Phenolic: 0.56 pf ±5%, 500 VDCW.	
C381	5491601P114	Phenolic: 0.51 pf ±5%, 500 VDCW.	1
C382	5491601P110	Phenolic: 0.36 pf ±5%, 500 VDCW.	
C385	7774750P4	Ceramic disc: .001 µf +100% -0%, 500 VDCW.	1
C386	5491601P116	Phenolic: 0.62 pf ±5%, 500 VDCW.	-
C387	5494481P12	Ceramic disc: 1000 pf ±10%, 1000 VDCW; sim to	١
and C388		RMC Type JF Discap.	-
	1	DIODES AND RECTIFIERS	
CR1*	19A116062P2	Thyrector. Deleted in 19E500873G4 by REV J. Deleted in 19E500873G5, G6 by REV H.	
		JACKS AND RECEPTACLES	-
J442	19B205689G2	Connector: 18 contacts rated at 5 amps min at 1000 VDC max.	
J443	19C303426G1	Connector: 20 pin contacts.	
		INDUCTORS	
L341		COIL ASSEMBLY	
thru L346		L341 19820482065 L342 19820482066 L343 19820482061 L344 19820482062 L345 198204820G3 L346 198204820G4	
C341	19B209159P3		
2341	1	750 v peak; sim to EF Johnson 189.	
C342*	19B209159P4	Variable, air, sub-miniature: 1.80-8.30 pf, 650 v peak; sim to EF Johnson 189.  In 19E500873G6 of REV N & earlier:	
	19B209159P3	Variable, air, sub-miniature: 1.70-6.9 pf,	
	19820913983	750 v peak; sim to EF Johnson 189.	
		INDICATING DEVICES	
DS301	19B209067P1	Lamp, glow: 0.3 ma; sim to GE NE-2T.	
55301			
P301 thru	4029840P2	Contact, electrical; sim to Amp 42827	Ì
P311		]	
P312	4029840P3	Contact, electrical; sim to Amp 42101-2.	
P313	4029840P2	Contact, electrical; sim to Amp 42827-2.	
P315 thru P317	4029840P2	Contact, electrical; sim to Amp 42827-2.	
		1	

DESCRIPTION

-	P319 and P320	4029840P2	Contact, electrical; sim to Amp 42827-2.	
- 1	P322	4029840P2	Contact, electrical; sim to Amp 42827-2.	
-	P323	4029840P1	Contact, electrical; sim to Amp 41854.	
-	P324 thru P326	4029840P2	Contact, electrical; sim to Amp 42827-2.	
	P327	4029840P1	Contact, electrical; sim to Amp 41854.	
- 1				
- 1	Q341* and	19A116741P1	Silicon, NPN.	
	Q342*		In 19E500873G4 of REV K & earlier: In 19E500873G5, G6 of REV J & earlier:	
,		19A116203P2	Silicon, NPN.	
w;	R341	3R152P822K	Composition: 8.2K ohms $\pm 10\%$ , 1/4 w.	
l	R342*	3R152P622J	Composition: 6.2K ohms ±5%, 1/4 w.	
			In 19E500873G4 of REV M. In 19E500873G5, G6 of REV L.	
		3R152P472J	Composition: 4.7K ohms ±5%, 1/4 w.	
			In 19E500873G4 REV L & earlier: In 19E500873G5, G6 REV K & earlier:	
		3R152P222K	Composition: 2.2K ohms ±10%, 1/4 w.	
	R343 and R344	3R152P101K	Composition: 100 ohms ±10%, 1/4 w.	
	R345	19A116278P444	Metal film: 280K ohms ±2%, 1/2 w.	
	R346	3R78P390K	Composition: 39 ohms ±10%, 1 w.	
·				
-	Т341	19A116041P2	Audio freq: 300 to 4000 Hz, ±0.5 dB, Pri: 23.5 ohms imp, at 50 mA, Sec 1: 3.5 ohms imp at 1 KHz, Sec 2: 10.15 ±0.10 VRMS.	
-	TB1	7487424P26	Miniature, phen: 6 terminals.	
	W441	19B205634G2	Coaxial: approx 5 inches long.	
			TUNED CIRCUITS	
	Z341 thru Z343		COIL ASSEMBLY Z341 19B204786G4 Z342 19B204786G5 Z343 19B204786G6	
			CAPACITORS	
	C1	5496218P254	Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 PPM.	
	C2	5496218P250	Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.	
	сз	5496218P245	Ceramic disc: 18 pf ±5%, 500 VDCW, temp coef -80 PPM.	
	C4	5494481P14	Ceramic disc: 2000 pf ±10%, 500 VDCW; sim to RMC Type JF Discap.	
	Ll		(Part of Coil Assembly).	
			MISCELLANEOUS	
		5491798P1	Tuning slug. (Used in Z341).	
		5491798P4	Tuning slug. (Used in Z342).	
		5491798P5	Tuning slug. (Used in Z343).	
		1	1	

DESCRIPTION

SYMBOL GE PART NO.

SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE
Z347 thru Z349		COIL ASSEMBLY Z347 199204767G1 Z348 199204767G2 Z349 198204767G3	R2	3R15
				5491
Cl	5496218P254	Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 PPM.		5491
C2	5496218P250	Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.	Z357 and Z358	
СЗ	5496218P245	Ceramic disc: 18 pf ±5%, 500 VDCw, temp coef -80 PPM.		
			C2	5496
L6		(Part of Coil Assembly).	сз	5496
		MISCELLANEOUS		
	5491798P1	Tuning slug. (Used in Z347).	L3	
	5491798P4	Tuning slug. (Used in Z348).	1 20	
	5491798P5	Tuning slug. (Used in Z349).		
Z350 thru Z352		COIL ASSEMBLY 2350 198204784G8 2351 198204784G9 2352 198204784G10		5491 <sup>4</sup>
			Z359 thru	
C7 and C8	5496218P248	Ceramic disc: 24 pf ±5%, 500 VDCW, temp coef -80 PPM.	2361	
C9	5496218P244	Ceramic disc: 15 pf ±5%, 500 VDCW, temp coef -80 PPM.		5400
C12	5496218P241	Ceramic disc: 10 pf ±0.25 pf, 500 VDCW, temp	C1	5496
C13	5496218P237	coef -80 PPM.  Ceramic disc: 6 pf ±0.25 pf, 500 VDCW, temp	C2	5496
C14	5496218P236	coef -80 PPM.  Ceramic disc: 5 pf ±0.25 pf, 500 VDCW, temp	C3	5496
-		coef -80 PPM.	C4	5494
			C5	5494
L7		(Part of Coil Assembly).		
		MISCELLANEOUS	CR1	19A1
	5491798P1	Tuning slug. (Used in Z350).		
	5491798P4 5491798P5	Tuning slug. (Used in Z351). Tuning slug. (Used in Z352).		
	0431136F3	luning stag. (cood in 2007)	1.4	
Z354 and Z355		COIL ASSEMBLY 2354 19B204767G4 2355 19B204767G5	1	5491
2000				5491
	5.40003.07050			5491
C2	5496218P250	coef -80 PPM.	Z362	
C3	5496218P245	Ceramic disc: 18 pf ±5%, 500 VDCW, temp coef -80 PPM.	thru Z364	
C4 and C5	5494481P12	Ceramic disc: 1000 pf $\pm 10\%$ , 1000 VDCW; sim to RMC Type JF Discap.		
		DIODES AND RECTIFIERS	C1	5496
CR1*	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV.  In 19E500873G4 of REV G & earlier:	C2	5496
		In 19E500873G5, G6 of REV F & earlier:	СЗ	5496
	7777146P3	Germanium.		l
		INDUCTORS	C4	5494
L2		(Part of Coil Assembly).	C5*	5494
		RESISTORS		
Rl	3R152P333K	Composition: 33K ohms ±10%, 1/4 w.		

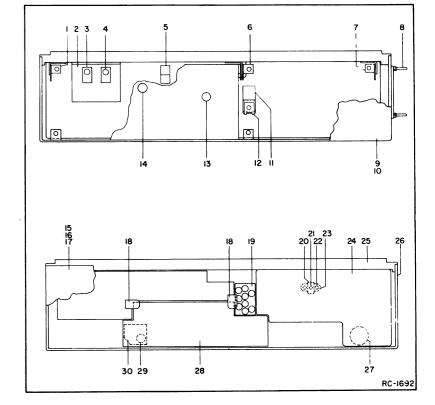
3491798P4	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART N
S481788P4	R2	3R152P183K	Composition: 18K ohms ±10%, 1/4 w.		
S491798P5   Tuning slug. (Used in 2355).			MISCELLANEOUS	CR1*	4038642P1
S491798P4		5491798P5			
C2 5496218P245 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C3 5496218P250 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C3 5496218P245 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C3 5496218P245 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C4 549178BP4 Tuning slug. (Used in 2357).  C5 549178BP5 Tuning slug. (Used in 2357).  C1 5496218P254 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C2 5496218P254 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C3 5496218P255 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C4 54944BP14 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C5 549448PP14 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C6 549448PP14 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C7 549448PP1 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 549448PP1 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 549448PP1 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 549448PP1 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 549448PP1 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 549448PP1 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 549448PP1 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 549448PP1 Geramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 549448PP1 Tuning slug. (Used in 2360).  C9 549448PP1 Tuning slug. (Used in 2360).  C9 549448PP1 Tuning slug. (Used in 2360).  C9 549448PP14 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C1 54952BP254 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C1 54962BP254 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C2 54962BP254 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C2 54962BP254 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C2 54962BP254 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C1 54964BP21 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C2 54964BP21 Ceramic disc: 30 pf 15%, 500 VECW, temp coef -80 PFM.  C8 54964BP21 Ceramic disc: 30 pf 15%, 500					
C2 5496218P250	and		Z357 19B204783G2	L5	
C2 5496218P245	2358			Rl*	3R152P202J
Coeff-80 PPM.  Coramic disc: 18 pf 15%, 500 VDCW, temp  Coeff-80 PPM.  13 (Part of Coil Amsembly).  5491798P4 Tuning slug. (Used in 2357).  5491798P5 Tuning slug. (Used in 2358).  2359 19820478503  C1 5498218P254 Coramic disc: 30 pf 15%, 500 VDCW, temp coeff-80 PPM.  C2 5496218P255 Coramic disc: 18 pf 15%, 500 VDCW, temp coeff-80 PPM.  C3 5494481P11 Coramic disc: 100 pf 120%, 1000 VDCW; sim to RMC Type JF Discap.  CR1 194116032P1 Hot carrier: Fwd. drop. 350 volts max.  NISCELLANEOUS			l		
C3	C2	5496218P250	Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.		2015204217
Carried disc: 1000 pf ±0%, 1000 VDCW; sin to RMC Type JF Discap.   S491798P4   Tuning slug. (Used in Z357).   S4948PP1   S491798P5   Tuning slug. (Used in Z358).   Coll. ASSEMBLY   Z359*   19820478501 (In REV N and earlier)   Z360   19820478501 (In REV N and earlier)   Z360   19820478501 (In REV N and earlier)   Z360   19820478502   Z361   19820478502   Z361   19820478503   Z361   19820478503   Z361   2882047801 (In REV N and earlier)   Z360   19820478502   Z361   19820478503   Z361   19820478503   Z361   2882047801   Z361   Z362   Z361   Z362   Z	СЗ	5496218P245			3R132P4313
S491798P4   Tuning slug. (Used in 2357).					5491798P1
Tuning slug. (Used in 2357).   Tuning slug. (Used in 2358).   COLL ASSEMBLY   2359*   19820478564 (In REV P)   19820478563   19820478563 (In REV N) and earlier)   2360   19820478563 (In REV N) and earlier)   2360   19820478563 (In REV N) and earlier)   2360   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478663   19820478663   19820478663   19820478663   19820478663   19820478663   19820478663   19820478663   19820478663   19820478663   19820478663   19820478663   19820478762   198204	L3		(Part of Coil Assembly).		5491798P4
S491798P4   Tuning slug. (Used in 2357).   Tuning slug. (Used in 2358).   COLL ASSEMENT   2359* 19820478561 (In REV N and earlier)   19820478561   19820478561 (In REV N and earlier)   2350* 19820478561 (In REV N and earlier)   2350* 19820478561 (In REV N and earlier)   2350* 19820478561 (In REV N and earlier)   2350* 19820478561 (In REV N and earlier)   2350* 19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   19820478563   1982047864   1982047864   1982047864   1982047864   1982047864   1982047864   1982047864   1982047864   1982047864   1982047864   19820478764			MISCRII ANDONIS		5491798P5
S491798P5   Tuning slug. (Used in 2358).		540150004	1		
COLL ASSEMBLY   2359* 19820478504 (10 REV P)   19820478505 (10 REV N and earlier)   2360 19820478505 (10 REV N and earlier)   2360 19820478505 (10 REV N and earlier)   2360 19820478505 (10 REV N and earlier)   2360 19820478505 (2361 19820478505)   2560 19820478505 (2560 19820478505)   2560 19820478505 (2560 19820478505)   2560 19820478505 (2560 19820478505)   2560 19820478505 (2560 19820478505)   2560 19820478505 (2560 19820478505)   2560 19820478505 (2560 19820478505)   2560 19820478505 (2560 19820478705)   2560 19820478705 (2560 19820478705)   2560 19820					
2359   198204785C1 (In REV P)   2360   198204785C1 (In REV N and earlier)   2360   198204785C3 (In REV N and earlier)   2360   198204785C3 (In REV N and earlier)   2360   198204785C3 (In REV N and earlier)   2360   198204785C3 (In REV N and earlier)   2360   198204785C3 (In REV N and earlier)   2360   198204785C3 (In REV N and earlier)   2360   198204785C3 (In REV N and earlier)   2360   198204785C3 (In REV N and earlier)   2360   2361   198204785C3 (In REV N and earlier)   2360   2361   2362		510110010	Lanning stage (vasts on essay)		
C1 5496218P254	thru		2359* 19B204785G4 (In REV P) 19B204785G1 (In REV N and earlier) 2360 19B204785G2		
C2 5496218P250 Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.  C3 5496218P245 Ceramic disc: 18 pf ±5%, 500 VDCW, temp coef -80 PPM.  C4 5494481P14 Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.  C5 5494481P11 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.  C7 194116032P1 Rot carrier: Fwd. drop .350 volts max.  DIODES AND RECTIFIERS  14 (Part of Coil Assembly).  C9 1941798P1 Tuning slug. (Used in 2359- before REV P).  5491798P4 Tuning slug. (Used in 2350).  5491798P5 Tuning slug. (Used in 2361).  C1 5496218P250 Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 PPM.  C2 5496218P250 Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.  C3 5496218P250 Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.  C4 5494481P14 Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to PMC Type JF Discap.  C5 5494481P14 Ceramic disc: 2000 pf ±20%, 1000 VDCW; sim to PMC Type JF Discap.  C5 5494481P11 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to PMC Type JF Discap.  C6 5494481P14 Ceramic disc: 2000 pf ±20%, 1000 VDCW; sim to PMC Type JF Discap.			CAPACITORS		
C3 5496218P245 Ceramic disc: 18 pf ±5%, 500 VDCW, temp coef -80 PPW.  C4 5494481P14 Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.  C5 5494481P11 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.  CR1 19A116052P1 Hot carrier: Fwd. drop .350 volts max.  INDUCTORS P321 4029840P2  CPART of Coil Assembly).  C9Art of Coil Assembly.  C9Art of Coil Assembly.  Tuning slug. (Used in Z359- before REV P).  5491798P1 Tuning slug. (Used in Z360).  5491798P5 Tuning slug. (Used in Z361).  C011 ASSEMBLY Z362 18920478761  Z362 thru Z364 19820478763  C1 5496218P254 Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 PPM.  C2 5496218P255 Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.  C3 5496218P255 Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.  C4 5494481P14 Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.  C6 Ceramic disc: 2000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.  C6 Ceramic disc: 2000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.  C7 5494481P11 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.  C6 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.  C6 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.  C7 5494481P11 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.	Cl	5496218P254	Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 PPM.		
Coef -80 PPM.  Coef -	C2	5496218P250			19B216176G1
C4 5494481P14   Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.   P328	СЗ	5496218P245		P314	4029840P2
CFAMIC disc: 1000 pf ±20%, 1000 VDCW; sim to RMC Type JF Discap.  CR1 19A116052P1 Hot carrier: Fwd. drop .350 volts max.  L4 (Part of Coil Assembly).  CPART of Coil Assembly).  19B216177	C4	5494481P14	Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to		4029840P2
CR1 19A116052P1 Hot carrier: Fwd. drop .350 volts max.	C5	5494481P11	Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to	P328 thru	4029840P2
19A116052P1			DIODES AND RECTIFIERS	1000	
198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   19821798P4   19821798P5   1982	CRl	19A116052P1			
198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216177   198216178   19821618   198216178   19821618   19821618   19821618   19821618   198216178   19821618   1982			INDUCTORS		
Tuning slug. (Used in Z359- before REV P).   P330   4029840P2	L4		(Part of Coil Assembly).		10001617761
Tuning slug. (Used in Z359- before REV P).   P330   4029840P2			MISCELLANEOUS	P321	
Tuning slug. (Used in Z360).   P332   4029840P2		E401709D1	1		
Tuning slug. (Used in Z361).					
Thru Z362 198204787G1 Z363 198204787G2 Z364 198204787G2 Z364 198204787G2 Z364 198204787G3  C1 5496218P254  Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 ppM.  C2 5496218P250  Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 ppM.  C3 5496218P245  Ceramic disc: 18 pf ±5%, 500 VDCW, temp coef -80 ppM.  C4 5494481P14  Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.  C5* 5494481P11  Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to 19C303385					102001012
Thru Z362 198204787G1 Z363 198204787G2 Z364 198204787G2 Z364 198204787G2 Z364 198204787G3  C1 5496218P254  Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 PPM.  C2 5496218P250  Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.  C3 5496218P245  Ceramic disc: 18 pf ±5%, 500 VDCW, temp coef -80 PPM.  C4 5494481P14  Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.  C5* 5494481P11  Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to 19C303385					
2   198216727   2   198216727   3   198116023   2   198216727   3   198116023   2   198216727   3   198116023   3   19811602			Z362 19B204787G1	1	19B204583G3
C1 5496218P254 Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 PPM.  C2 5496218P250 Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.  C3 5496218P245 Ceramic disc: 18 pf ±5%, 500 VDCW, temp coef -80 PPM.  C4 5494481P14 Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.  C5* 5494481P11 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to 19C303385	Z364		Z363 19B204787G2 Z364 19B204787G3	2	19B216727P1
C1 5496218P254 Ceramic disc: 43 pf ±5%, 500 VDCW, temp coef -80 PPM.  C2 5496218P250 Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.  C3 5496218P245 Ceramic disc: 18 pf ±5%, 500 VDCW, temp coef -80 PPM.  C4 5494481P14 Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to RMC Type JF Discap.  C5* 5494481P11 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to			CADACUTORS	3	19A116023P2
C2 5496218P250 Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef		540001 07054		4	19A115222P3
-80 PPM.  C3 5496218P245	C1	3490219F234	-80 PPM.	5	4029851P6
C3 5496218P245	C2	5496218P250	Ceramic disc: 30 pf ±5%, 500 VDCW, temp coef -80 PPM.		19B204583G1
C4 5494481P14 Ceramic disc: 2000 pf ±10%, 1000 VDCW; sim to		5496218P245		11	19B204583G2 19A121676P1
RMC Type JF Discap.  C5* 5494481P11 Ceramic disc: 1000 pf ±20%, 1000 VDCW; sim to	C3	I		`	
C5*   5494481P11   Ceramic disc: 1000 pr ±20%, 1000 vpcw; sim to		5494481P14		9	19030339664
RMC Type JF Discap. 11 19A121297 Added to 19E500873G4 by REV M.	C4		RMC Type JF Discap.		19C303396G4

	SYMBOL	GE PART NO.	DESCRIPTION
	CR1*	4038642P1	DIODES AND RECTIFIERS
	CRIT	4036042P1	Added to 19E500873G5, G6 by REV L.
	L5		(Part of Coil Assembly).
			RESISTORS
	R1*	3R152P202J	Composition: 2K ohms ±5%, 1/4 w.
			In 19E500873G4 of REV L & earlier: In 19E500873G5, G6 of REV K & earlier:
		3R152P431J	Composition: 430 ohms ±5%, 1/4 w.
			MISCELLANEOUS
		5491798P1	Tuning slug. (Used in Z362).
		5491798P4	Tuning slug. (Used in Z363).
_		5491798P5	Tuning slug. (Used in Z364)
			HARNESS ASSEMBLY 19E500873G14
			(Includes C385, C387, C388, J442, J443, P301- P304, P307-P313, P315-P317, P319, P320, P322- P327, R345, R346, T341).
r)			P327, R345, R346, T341).
-			CHANNEL GUARD MODIFICATION KIT 19A127178G1
ef			(Used with A350)
			MISCELLANEOUS
		19B216176G1	Harness (Encoder/Decoder). Includes:
	P314	4029840P2	Contact, electrical; sim to Amp 42827-2.
to	P318	4029840P2	Contact, electrical; sim to Amp 42827-2.
	P321	4029840P2	Contact, electrical; sim to Amp 42827-2.
to	P328 thru P335	4029840P2	Contact, electrical; sim to Amp 42827-2.
			CHANNEL GUARD MODIFICATION KIT
			19A127178G2 (Used with A402)
			MISCELLANEOUS
		19B216177G1	Harness (Tone Reject Filter). Includes:
	P321	4029840P2	Contact, electrical; sim to Amp 42827-2.
	P330	4029840P2	Contact, electrical; sim to Amp 42827-2.
	P332	4029840P2	Contact, electrical; sim to Amp 42827-2.
	I I	l	1

Clip, loop.
Hinge.
Hinge.
Guide pin.

7160861P4 4036555P1 Bottom cover. (Station)

	SYMBOL	GE PART NO.	DESCRIPTION
	14 15	4035267P2 19C303495G3	Button, plug. (Used with A348, A350 and A402). Top cover. (Station, except Repeaters and VM).
	16	19C303676G2	Top cover. (Station, Repeaters and VM only).
	17	19C303385P2 4029851P3	Top cover. (Mobile) Clip, loop.
	19 20	19A121383P1 4033089P1	Support. Clip. (Part of XY1-XY4).
	21 22	19B200525P9 19A115793P1	Rivet. (Part of XY1-XY4).  Contact. (Part of XY1-XY4).
	23	4039307P1 19C303547P1	Crystal socket. (Part of XY1-XY4), Cover.
	25	19C317344P3	Heat sink. Chassis,
	27	4034252P5	Can (Used with Tl on A347).
	28 29	19B204672P1 7162414P1	Cover.  Retainer, transistor. (Used with Q1 on A341).
_	30	19B204917P1	Support.
-			



#### LBI4124

## **PRODUCTION CHANGES**

Changes in the equipment to improve performance or to simplify circuits are identified by a "Revision Letter". which is stamped after the model number of the unit. The revision stamped on the unit includes all previous revisions. Refer to the Parts List for descriptions of parts affected by these revisions.

- REV. A 2nd Mixer A347 (19B216119-G1)
  Channel Guard Encoder/Decoder Model 4EK16A10 (19C311797-G1)
  1st Osc/Mult A354 A357 (19B204419-G14, 15, 17, 18)
- REV. C 1st Osc/Mult A352 & A353 (19B204419-G13 G18) IF-Audio & Squelch A348 (19D413129-G1)
- REV. F Chassis & RF Assembly (19E500873-G4 thru G6) These revisions incorporated into initial shipment.
- REV. B Channel Guard Encoder/Decoder Model 4EK16A10 (19C311797-G1) To increase the stop-band attenuation. Changed R8.
- REV. C Channel Guard Encoder/Decoder Model 4EK16Al0 (19C311797-G1) REV. A - Tone Reject Filter (19C311797-G2) To optimize the frequency response. Changed C29.
- REV. D Channel Guard Encoder/Decoder Model 4EK16A10 (19C311797-G1) REV. B Tone Reject Filter (19C311797-G2)

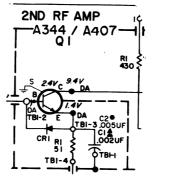
To prevent excessive roll-off at 300 Hertz. Changed R59.

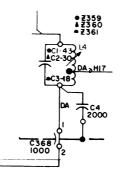
- REV. D IF-Audio & Squelch A348 (19D413129-G1) To improve frequency response at 3000 Hertz. Changed R30 & R78
- REV. G Chassis & RF Assembly (19E500873-G4) To improve the blanker performance. Added A407 and C2 to 2nd RF Amplifier.

#### IF-Audio & Squelch A348 (19D413129G1)

- REV. E To compensate for vendor change. Changed C26.
- REV. F To improve squelch action. Changed R53.
- REV. G To improve operation. Changed CR3 and CR4.
- REV. H To improve squelch action at -30°C.
- REV. H Chassis & RF Assembly (19E500873G4) To incorporate silicon diode. Changed CRl.
- REV. J To eliminate unnecessary protection. Deleted CR1.
- REV. K To improve tuning. Deleted R14 on crystal filter A404.
- REV. L To incorporate new transistors. Changed Q341 and Q342.
- REV. G Chassis & RF Assembly (19E500873G5 & G6) To incorporate silicon diode. Changed CR1.
- REV. H To eliminate unnecessary protection. Deleted CR1.
- REV. J To improve tuning. Deleted R14 on crystal filter A404.
- REV. K To incorporate new transistors. Changed Q341 and Q342.
- REV. L Chassis & RF Assembly (19E500873G5 & G6) REV. M - Chassis & RF Assembly (19E500873G4)
  - To improve blanker performance. Changed R342. Changed R1 and added C5 and CR1 to RF Amplifier A344. Changed R1. Deleted CR1 and added C3 to RF Amplifier A407. Schematic Diagram was:

#### SCHEMATIC DIAGRAM WAS:





- - REV. M Chassis & RF Assembly (19E500873G5 & G6 Changed Q10. REV. N - Chassis & RF Assembly (19E500873G4
  - To increase RF attenuation for proper blanking. Changed R342.
    - REV. F Noise Blanker Board (19C303540G1 & G2 To increase RF attenuation for proper blanking. Changed C42.

REV. D - Noise Blanker Board (19C303540G1,2 & 3

system. C21, C17, R22 & CR2.

REV. E - Noise Blanker Board (19C303540G1,G2 & G3)

C6 thru C16, CR3, Q4, R12 and R13.

To improve metering in positive ground

To improve blanker performance. Changed

- REV. J IF-Audio & Squelch A348 (19D413129G1 To correct PA bias. Changed R40.
- REV. K To improve stability of audio output with no load. Added R85.
- REV. L To improve frequency response at 300 Hz. Deleted R85 and Changed C40.
- REV. M To improve audio quality. Changed R80.
- REV. N To improve frequency response. Changed C26.
- REV. P To improve stability. Changed Q5.
- REV. F Noise Blanker Board (19C303540G3) To improve blanker restoration. Changed C29.
- REV. P Chassis & RF Assembly (19E500873G4) To improve operation. Changed Z359.
- REV. R To incorporate new transistor. Changed Q2.
- REV. N Chassis & RF Assembly (19E500873G5 & G6) To incorporate new transistor. Changed Q2.
- REV. P Chassis & RF Assembly (19E500873G6) To improve tuning range of 2nd RF stage. Changed C342.
- REV. R IF Audio & Squelch A348 (19D413129G1) To improve Squelch action. Deleted R56 and added R86.

PRODUCTION CHANGES 25-50 MHz MASTR RECEIVER

MODELS 4ER39C68-85

Issue 8

#### **ORDERING SERVICE PARTS**

Each component appearing on the schematic diagram is identified by a symbol number, to simplify locating it in the parts list. Each component is listed by symbol number, followed by its description and GE Part Number.

Service parts may be obtained from Authorized GE Communication Equipment Service Stations or through any GE Radio Communication Equipment Sales Office. When ordering a part, be sure to give:

- 1. GE Part Number for component
- 2. Description of part
  3. Model number of equi Model number of equipment
- 4. Revision letter stamped on unit

These instructions do not purport to cover all details or variations in equipment nor to provide for every possible contingency to be met in connection with installation, operation or maintenance.

Should further information be desired, or should particular problems arise which are not covered sufficiently for the purchaser's purposes, contact the nearest Radio Communication Equipment Sales Office of the General Electric Company.

MOBILE RADIO DEPARTMENT
GENERAL ELECTRIC COMPANY ● LYNCHBURG, VIRGINIA 24502

